



OET 65

TEST REPORT

Product Name	5.8G USB Dongle
Model	USB TX
Brand Name	ASTRO
FCC ID	YQ6-AG20130004
Client	Astro Gaming, Inc.
Manufacturer	Shenzhen Grandsun Electronic Co.,Ltd
Date of issue	May 16, 2013

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GENERAL SUMMARY

Reference Standard(s)	<p>FCC 47CFR §2.1093 Radiofrequency Radiation Exposure Evaluation: Portable Devices</p> <p>ANSI C95.1, 1992: Safety Levels with Respect to Human Exposure to Radio Frequency Electromagnetic Fields, 3 kHz to 300 GHz.(IEEE Std C95.1-1991)</p> <p>SUPPLEMENT C Edition 01-01 to OET BULLETIN 65 Edition 97-01 June 2001 including DA 02-1438, published June 2002: Evaluating Compliance with FCC Guidelines for Human Exposure to Radio frequency Electromagnetic Fields Additional Information for Evaluation Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radio frequency Emissions.</p> <p>KDB 865664 D01 SAR measurement 100 MHz to 6 GHz v01 SAR Measurement Requirements for 100 MHz to 6 GHz</p> <p>KDB 447498 D01 Mobile Portable RF Exposure v05: Mobile and Portable Device RF Exposure Procedures and Equipment Authorization Policies</p> <p>KDB 447498 D02 SAR Procedures for Dongle Xmtr v02: SAR Measurement Procedures for USB Dongle Transmitters.</p>
Conclusion	<p>This portable wireless equipment has been measured in all cases requested by the relevant standards. Test results in Chapter 7 of this test report are below limits specified in the relevant standards for the tested bands only.</p> <p>General Judgment: Pass</p>
Comment	<p>The test result only responds to the measured sample.</p>

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1. General Information

1.1. Notes of the Test Report

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TA Technology (Shanghai) Co., Ltd. guarantees the reliability of the data presented in this test report, which is the results of measurements and tests performed for the items under test on the date and under the conditions stated in this test report and is based on the knowledge and technical facilities available at TA Technology (Shanghai) Co., Ltd. at the time of execution of the test.

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If the electrical report is inconsistent with the printed one, it should be subject to the latter.

1.2. Testing Laboratory

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1.3. Applicant Information

Company: Astro Gaming, Inc.
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1.4. Manufacturer Information

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City: Shenzhen
Postal Code: /
Country: China

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1.5. Information of EUT

General Information

Device Type:	Portable Device
Exposure Category:	Uncontrolled Environment / General Population
State of Sample:	Prototype Unit
IMEI:	/
Hardware Version:	/
Software Version:	/
Antenna Type:	Internal Antenna
Device Operating Configurations:	
Operating Mode(s):	5736MHz - 5814MHz; (tested)
Test Modulation:	QPSK
Operating Frequency Range(s):	Low: 5736MHz, Middle: 5762MHz, High 5814MHz.

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Equipment Under Test (EUT) has a 5.8G internal antenna that is used for Tx/Rx. During SAR test of the EUT, it was connected to a portable computer.

The sample undergoing test was selected by the Client.

Components list please refer to documents of the manufacturer.

1.6. The Maximum Reported SAR_{1g}

Body Worn Configuration

Mode	Test Position	Channel /Frequency(MHz)	Limit SAR _{1g} 1.6 W/kg	
			Measured SAR _{1g} (W/kg)	Reported SAR _{1g} (W/kg)
5.8G	Test Position 4/Right Side	Low/5736	0.301	0.322

1.7. Test Date

The test performed on May 14, 2013.

2. SAR Measurements System Configuration

2.1. SAR Measurement Set-up

The DASY5 system for performing compliance tests consists of the following items:

- A standard high precision 6-axis robot (Stäubli RX family) with controller and software. An arm extension for accommodating the data acquisition electronics (DAE).
- A dosimetric probe, i.e. an isotropic E-field probe optimized and calibrated for usage in tissue simulating liquid. The probe is equipped with an optical surface detector system.
- A data acquisition electronic (DAE) which performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. The unit is battery powered with standard or rechargeable batteries. The signal is optically transmitted to the EOC.
- A unit to operate the optical surface detector which is connected to the EOC.
- The Electro-Optical Coupler (EOC) performs the conversion from the optical into a digital electric signal of the DAE. The EOC is connected to the DASY5 measurement server.
- The DASY5 measurement server, which performs all real-time data evaluation for field measurements and surface detection, controls robot movements and handles safety operation. A computer operating Windows 2003
- DASY5 software and SEMCAD data evaluation software.
- Remote control with teach panel and additional circuitry for robot safety such as warning lamps, etc.
- The generic twin phantom enabling the testing of left-hand and right-hand usage.
- The device holder for handheld mobile phones.
- Tissue simulating liquid mixed according to the given recipes.
- System validation dipoles allowing to validate the proper functioning of the system.

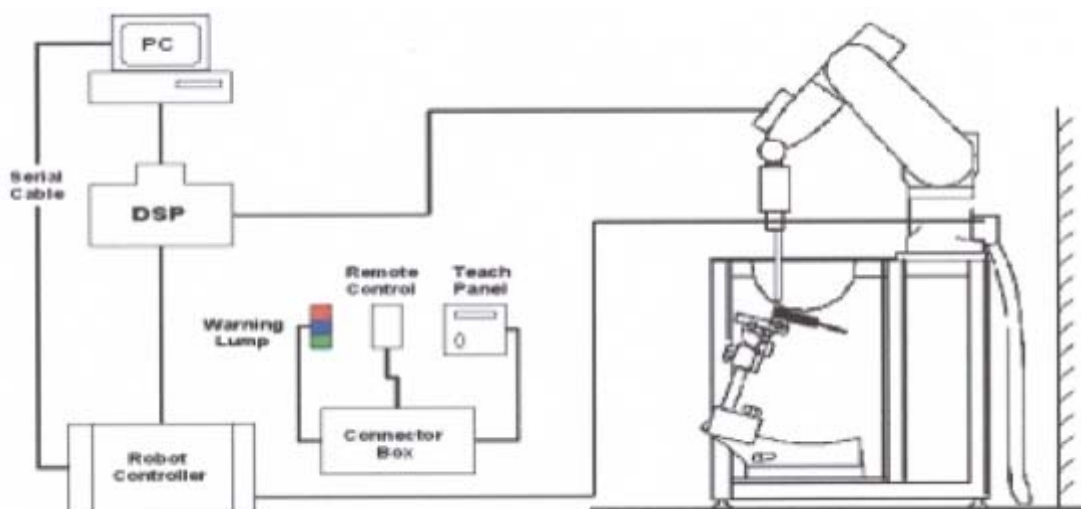


Figure 1. SAR Lab Test Measurement Set-up

2.2. DASY5 E-field Probe System

The SAR measurements were conducted with the dosimetric probe EX3DV4 (manufactured by SPEAG), designed in the classical triangular configuration and optimized for dosimetric evaluation.

2.2.1. EX3DV4 Probe Specification

Construction	Symmetrical design with triangular core Built-in shielding against static charges PEEK enclosure material (resistant to organic solvents, e.g., DGBE)
Calibration	ISO/IEC 17025 calibration service available
Frequency	10 MHz to > 6 GHz Linearity: ± 0.2 dB (30 MHz to 6 GHz)
Directivity	± 0.3 dB in HSL (rotation around probe axis) ± 0.5 dB in tissue material (rotation normal to probe axis)
Dynamic Range	10 μ W/g to > 100 mW/g Linearity: ± 0.2 dB (noise: typically < 1 μ W/g)
Dimensions	Overall length: 330 mm (Tip: 20 mm) Tip diameter: 2.5 mm (Body: 12 mm) Typical distance from probe tip to dipole centers: 1 mm
Application	High precision dosimetric measurements in any exposure scenario (e.g., very strong gradient fields). Only probe which enables compliance testing for frequencies up to 6 GHz with precision of better 30%.



Figure 2. EX3DV4 E-field Probe



Figure 3. EX3DV4 E-field probe

2.2.2. E-field Probe Calibration

Each probe is calibrated according to a dosimetric assessment procedure with accuracy better than $\pm 10\%$. The spherical isotropy was evaluated and found to be better than $\pm 0.25\text{dB}$. The sensitivity parameters (NormX, NormY, NormZ), the diode compression parameter (DCP) and the conversion factor (ConvF) of the probe are tested.

The free space E-field from amplified probe outputs is determined in a test chamber. This is performed in a TEM cell for frequencies below 1 GHz, and in a wave guide above 1 GHz for free space. For the free space calibration, the probe is placed in the volumetric center of the cavity and at the proper orientation with the field. The probe is then rotated 360 degrees.

E-field temperature correlation calibration is performed in a flat phantom filled with the appropriate simulated brain tissue. The measured free space E-field in the medium correlates to temperature rise in a dielectric medium. For temperature correlation calibration a RF transparent thermistor-based temperature probe is used in conjunction with the E-field probe.

$$\text{SAR} = C \frac{\Delta T}{\Delta t}$$

Where: Δt = Exposure time (30 seconds),

C = Heat capacity of tissue (brain or muscle),

ΔT = Temperature increase due to RF exposure.

Or

$$\text{SAR} = \frac{|E|^2 \sigma}{\rho}$$

Where:

σ = Simulated tissue conductivity,

ρ = Tissue density (kg/m^3).

2.3. Other Test Equipment

2.3.1. Device Holder for Transmitters

Construction: Simple but effective and easy-to-use extension for Mounting Device that facilitates the testing of larger devices according to IEC 62209-2 (e.g., laptops, cameras, etc.) It is lightweight and fits easily on the upper part of the Mounting Device in place of the phone positioner. The extension is fully compatible with the Twin SAM, ELI4 and SAM v6.0 Phantoms.

Material: POM, Acrylic glass, Foam

2.3.2. Phantom

The Generic Twin Phantom is constructed of a fiberglass shell integrated in a wooden Figure. The shape of the shell is based on data from an anatomical study designed to determine the maximum exposure in at least 90% of all users. It enables the dosimetric evaluation of left and right hand phone usage as well as body mounted usage at the flat phantom region. A cover prevents the evaporation of the liquid. Reference markings on the Phantom allow the complete setup of all predefined phantom positions and measurement grids by manually teaching three points in the robot.

Shell Thickness	2±0.1 mm
Filling Volume	Approx. 20 liters
Dimensions	810 x 1000 x 500 mm (H x L x W) Available Special



Figure 4 Generic Twin Phantom

2.4. Scanning Procedure

The DASY5 installation includes predefined files with recommended procedures for measurements and validation. They are read-only document files and destined as fully defined but unmeasured masks. All test positions (head or body-worn) are tested with the same configuration of test steps differing only in the grid definition for the different test positions.

- The “reference” and “drift” measurements are located at the beginning and end of the batch process. They measure the field drift at one single point in the liquid over the complete procedure. The indicated drift is mainly the variation of the DUT’s output power and should vary max. $\pm 5\%$.
- The “surface check” measurement tests the optical surface detection system of the DASY5 system by repeatedly detecting the surface with the optical and mechanical surface detector and comparing the results. The output gives the detecting heights of both systems, the difference between the two systems and the standard deviation of the detection repeatability. Air bubbles or refraction in the liquid due to separation of the sugar-water mixture gives poor repeatability (above $\pm 0.1\text{mm}$). To prevent wrong results tests are only executed when the liquid is free of air bubbles. The difference between the optical surface detection and the actual surface depends on the probe and is specified with each probe. (It does not depend on the surface reflectivity or the probe angle to the surface within $\pm 30^\circ$.)
- Area Scan
The Area Scan is used as a fast scan in two dimensions to find the area of high field values

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before running a detailed measurement around the hot spot. Before starting the area scan a grid spacing is set according to FCC KDB Publication 865664. During scan the distance of the probe to the phantom remains unchanged.

After finishing area scan, the field maxima within a range of 2 dB will be ascertained.

- Zoom Scan

After the maximum interpolated values were calculated between the points in the cube, the SAR was averaged over the spatial volume (1g or 10g) using a 3D-Spline interpolation algorithm. The 3D-spline is composed of three one-dimensional splines with the “Not a knot” condition (in x, y, and z directions). The volume was then integrated with the trapezoidal algorithm.

- Spatial Peak Detection

The procedure for spatial peak SAR evaluation has been implemented and can determine values of masses of 1g and 10g, as well as for user-specific masses. The DASY5 system allows evaluations that combine measured data and robot positions, such as:

- maximum search
- extrapolation
- boundary correction
- peak search for averaged SAR

During a maximum search, global and local maxima searches are automatically performed in 2-D after each Area Scan measurement with at least 6 measurement points. It is based on the evaluation of the local SAR gradient calculated by the Quadratic Shepard's method. The algorithm will find the global maximum and all local maxima within -2 dB of the global maxima for all SAR distributions.

Extrapolation routines are used to obtain SAR values between the lowest measurement points and the inner phantom surface. The extrapolation distance is determined by the surface detection distance and the probe sensor offset. Several measurements at different distances are necessary for the extrapolation. Extrapolation routines require at least 10 measurement points in 3-D space.

They are used in the Zoom Scan to obtain SAR values between the lowest measurement points and the inner phantom surface. The routine uses the modified Quadratic Shepard's method for extrapolation.

- A Z-axis scan measures the total SAR value at the x-and y-position of the maximum SAR value found during the cube scan. The probe is moved away in z-direction from the bottom of the SAM phantom in 5mm steps.

Table 1: Area and Zoom Scan Resolutions per FCC KDB Publication 865664 D01v01

Frequency	Maximum Area Scan Resolution (mm) (Δx_{area} , Δy_{area})	Maximum Zoom Scan Resolution (mm) (Δx_{zoom} , Δy_{zoom})	Maximum Zoom Scan Spatial Resolution (mm) $\Delta z_{\text{zoom}}(n)$	Minimum Zoom Scan Volume (mm) (x,y,z)
≤ 2 GHz	≤ 15	≤ 8	≤ 5	≥ 30
2-3 GHz	≤ 12	≤ 5	≤ 5	≥ 30
3-4 GHz	≤ 12	≤ 5	≤ 4	≥ 28
4-5 GHz	≤ 10	≤ 4	≤ 3	≥ 25
5-6 GHz	≤ 10	≤ 4	≤ 2	≥ 22

2.5. Data Storage and Evaluation

2.5.1. Data Storage

The DASY5 software stores the acquired data from the data acquisition electronics as raw data (in microvolt readings from the probe sensors), together with all necessary software parameters for the data evaluation (probe calibration data, liquid parameters and device frequency and modulation data) in measurement files with the extension “.DAE4”. The software evaluates the desired unit and format for output each time the data is visualized or exported. This allows verification of the complete software setup even after the measurement and allows correction of incorrect parameter settings. For example, if a measurement has been performed with a wrong crest factor parameter in the device setup, the parameter can be corrected afterwards and the data can be re-evaluated.

The measured data can be visualized or exported in different units or formats, depending on the selected probe type ([V/m], [A/m], [°C], [mW/g], [mW/cm²], [dBrel], etc.). Some of these units are not available in certain situations or show meaningless results, e.g., a SAR output in a lossless media will always be zero. Raw data can also be exported to perform the evaluation with other software packages.

2.5.2. Data Evaluation by SEMCAD

The SEMCAD software automatically executes the following procedures to calculate the field units from the microvolt readings at the probe connector. The parameters used in the evaluation are stored in the configuration modules of the software:

Probe parameters:	- Sensitivity	Normi, a _{i0} , a _{i1} , a _{i2}
	- Conversion factor	ConvF _i
	- Diode compression point	Dcp _i
Device parameters:	- Frequency	f
	- Crest factor	cf
Media parameters:	- Conductivity	
	- Density	

These parameters must be set correctly in the software. They can be found in the component documents or they can be imported into the software from the configuration files issued for the DASY5 components. In the direct measuring mode of the multimeter option, the parameters of the actual system setup are used. In the scan visualization and export modes, the parameters stored in the corresponding document files are used.

The first step of the evaluation is a linearization of the filtered input signal to account for the compression characteristics of the detector diode. The compensation depends on the input signal, the diode type and the DC-transmission factor from the diode to the evaluation electronics.

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If the exciting field is pulsed, the crest factor of the signal must be known to correctly compensate for peak power. The formula for each channel can be given as:

$$V_i = U_i + U_i^2 \cdot c f / d c p_i$$

With V_i = compensated signal of channel i (i = x, y, z)

U_i = input signal of channel i (i = x, y, z)

cf = crest factor of exciting field (DASY parameter)

dcp_i = diode compression point (DASY parameter)

From the compensated input signals the primary field data for each channel can be evaluated:

E-field probes: $E_i = (V_i / Norm_i \cdot ConvF)^{1/2}$

H-field probes: $H_i = (V_i)^{1/2} \cdot (a_{i0} + a_{i1} f + a_{i2} f^2) / f$

With V_i = compensated signal of channel i (i = x, y, z)

$Norm_i$ = sensor sensitivity of channel i (i = x, y, z)
[mV/(V/m)²] for E-field Probes

$ConvF$ = sensitivity enhancement in solution

a_{ij} = sensor sensitivity factors for H-field probes

f = carrier frequency [GHz]

E_i = electric field strength of channel i in V/m

H_i = magnetic field strength of channel i in A/m

The RSS value of the field components gives the total field strength (Hermitian magnitude):

$$E_{tot} = (E_x^2 + E_y^2 + E_z^2)^{1/2}$$

The primary field data are used to calculate the derived field units.

$$SAR = (E_{tot})^2 \cdot \sigma / (\rho \cdot 1000)$$

with SAR = local specific absorption rate in mW/g

E_{tot} = total field strength in V/m

σ = conductivity in [mho/m] or [Siemens/m]

ρ = equivalent tissue density in g/cm³

Note that the density is normally set to 1 (or 1.06), to account for actual brain density rather than the density of the simulation liquid. The power flow density is calculated assuming the excitation field to be a free space field.

$$P_{pwe} = E_{tot}^2 / 3770 \quad \text{or} \quad P_{pwe} = H_{tot}^2 \cdot 37.7$$

with P_{pwe} = equivalent power density of a plane wave in mW/cm²

E_{tot} = total electric field strength in V/m

H_{tot} = total magnetic field strength in A/m

3. Laboratory Environment

Table 2: The Requirements of the Ambient Conditions

Temperature	Min. = 18°C, Max. = 25 °C
Relative humidity	Min. = 30%, Max. = 70%
Ground system resistance	< 0.5 Ω
Ambient noise is checked and found very low and in compliance with requirement of standards. Reflection of surrounding objects is minimized and in compliance with requirement of standards.	

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4. Tissue-equivalent Liquid

4.1. Tissue-equivalent Liquid Ingredients

The liquid is consisted of water, salt, Glycol. The liquid has previously been proven to be suited for worst-case. Table 3 shows the detail solution. It's satisfying the latest tissue dielectric parameters requirements proposed by the OET 65.

Table 3: Composition of the Body Tissue Equivalent Matter

MIXTURE%	FREQUENCY(Body) 5800MHz		
Water	72.6		
Glycol	27.3		
Salt	0.1		
Dielectric Parameters Target Value	f=5800MHz	$\epsilon=48.20$	$\sigma=6.00$

4.2. Tissue-equivalent Liquid Properties

Table 4: Dielectric Performance of Tissue Simulating Liquid

Frequency	Test Date	Temp ℃	Measured Dielectric Parameters		Target Dielectric Parameters		Limit (Within $\pm 5\%$)	
			ϵ_r	$\sigma(\text{s/m})$	ϵ_r	$\sigma(\text{s/m})$	Dev $\epsilon_r(\%)$	Dev $\sigma(\%)$
5800MHz (body)	2013-5-14	21.5	47.59	6.135	48.20	6.00	-1.27	2.25

5. System Check

5.1. Description of System Check

The manufacturer calibrates the probes annually. Dielectric parameters of the tissue simulants were measured every day using the dielectric probe kit and the network analyzer. A system check measurement was made following the determination of the dielectric parameters of the simulant, using the dipole validation kit. A power level of 100 mW was supplied to the dipole antenna, which was placed under the flat section of the twin SAM phantom. The system check results (dielectric parameters and SAR values) are given in the table 5.

System check results have to be equal or near the values determined during dipole calibration with the relevant liquids and test system ($\pm 10\%$).

System check is performed regularly on all frequency bands where tests are performed with the DASY5 system.

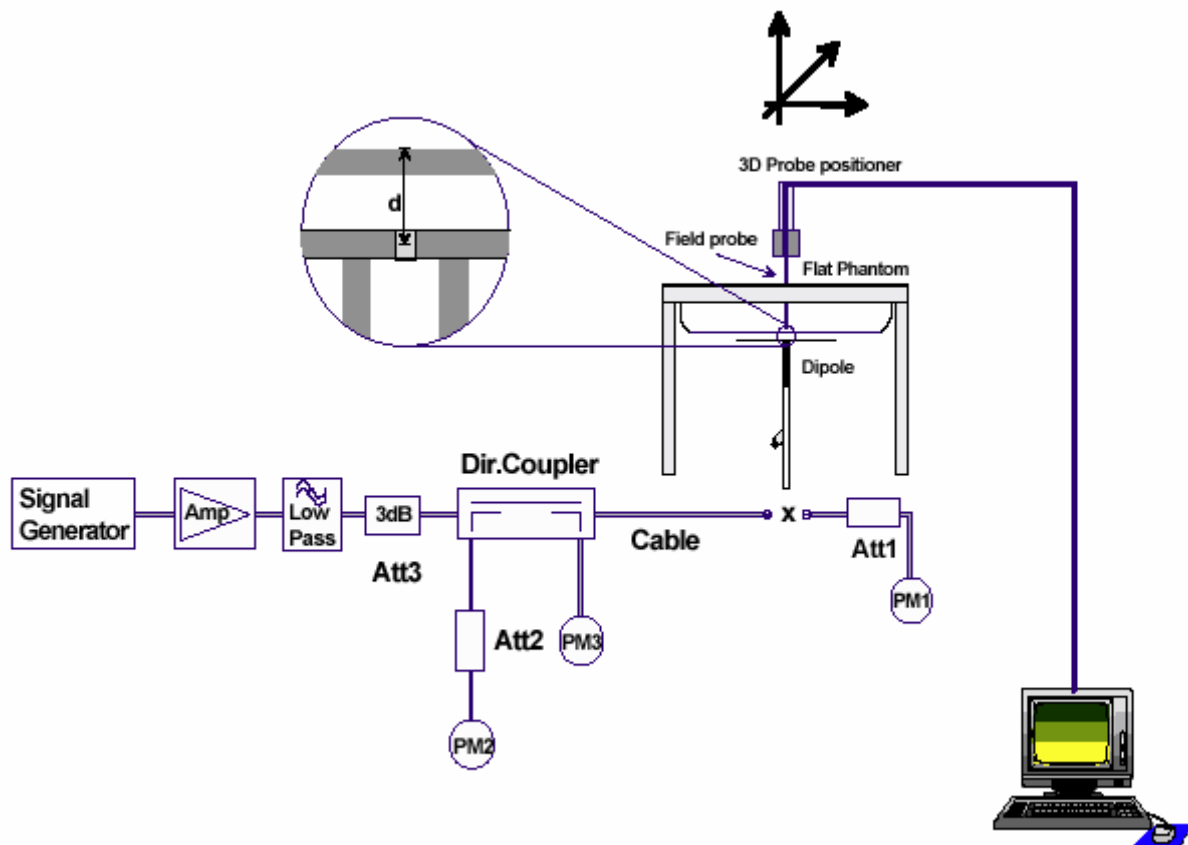


Figure 5. System Check Set-up

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5.2. System Check Results

Table 5: System Check in Body Tissue Simulating Liquid

Frequency	Test Date	Dielectric Parameters		Temp	100mW Measured SAR _{1g}	1W Normalized SAR _{1g}	1W Target SAR _{1g}	Limit (±10% Deviation)
		ε _r	σ(s/m)	(°C)	(W/kg)			
5800MHz	2013-5-14	47.59	6.135	21.5	7.1	71	73.8	-3.8%

Note: 1. The graph results see ANNEX B.

2. Target Values used derive from the calibration certificate

6. Operational Conditions during Test

6.1. General Description of Test Procedures

For SAR testing, Testing software installed on the EUT can provide continuous transmitting RF signal, and comand the EUT operated with maximum output power at fixed frequency .This RF signal utilized in SAR measurement has almost 100% duty cycle and its crest factor is 1.

6.2. Measurement Variability

Per FCC KDB Publication 865664 D01v01, SAR measurement variability was assessed for each frequency band, which was determined by the SAR probe calibration point and tissue-equivalent medium used for the device measurements. When both head and body tissue-equivalent media were required for SAR measurements in a frequency band, the variability measurement procedures were applied to the tissue medium with the highest measured SAR, using the highest measured SAR configuration for that tissue-equivalent medium. These additional measurements were repeated after the completion of all measurements requiring the same head or body tissue-equivalent medium in a frequency band. The test device was returned to ambient conditions (normal room temperature) with the battery fully charged before it was re-mounted on the device holder for the repeated measurement(s) to minimize any unexpected variations in the repeated results.

SAR Measurement Variability was assessed using the following procedures for each frequency band:

- 1) When the original highest measured SAR is ≥ 0.80 W/kg, the measurement was repeated once.
- 2) A second repeated measurement was preformed only if the ratio of largest to smallest SAR for the original and first repeated measurements was > 1.20 or when the original or repeated measurement was ≥ 1.45 W/kg (~ 10% from the 1-g SAR limit).
- 3) A third repeated measurement was performed only if the original, first or second repeated measurement was ≥ 1.5 W/kg and the ratio of largest to smallest SAR for the original, first and second repeated measurements is > 1.20 .
- 4) Repeated measurements are not required when the original highest measured SAR is < 0.80 W/kg

6.3. Test Positions

The EUT was connected to a portable computer.

A test distance of 5mm or less, according to KDB 447498 D02, should be considered for the orientation that can satisfy such requirements.

For each channel, the EUT is tested at the following 5 test positions:

- Test Position 1: The back side of the EUT towards to the bottom of the flat phantom. The distance from back side of the EUT to the bottom of the flat phantom is 5mm. (ANNEX G Picture 4)
- Test Position 2: The front side of the EUT towards the bottom of the flat phantom. The distance from front side of the EUT to the bottom of the flat phantom is 5mm. (ANNEX G Picture 5)
- Test Position 3: The left side of the EUT towards the bottom of the flat phantom. The distance from left side of the EUT to the bottom of the flat phantom is 5mm. (ANNEX G Picture 6)
- Test Position 4: The right side of the EUT towards the bottom of the flat phantom. The distance from right side of the EUT to the bottom of the flat phantom is 5mm. (ANNEX G Picture 7)
- Test Position 5: The top side of the EUT towards the bottom of the flat phantom. The distance from top side of the EUT to the bottom of the flat phantom is 5mm. (ANNEX G Picture 8)

7. Test Results

7.1. Conducted Power Results

Table 6: Conducted Power Measurement Results

5.8G	5736 MHz	5762 MHz	5814 MHz
Average Conducted Power (dBm)	10.71	9.89	7.95

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7.2. SAR Test Results

7.2.1. 5.8G

Table 7: SAR Values

Test Position	Channel/ Frequency (MHz)	Service	Duty Cycle	Maximum Allowed Power (dBm)	Conducted Power (dBm)	Drift $\pm 0.21\text{dB}$	Limit SAR _{1g} 1.6 W/kg			
						Drift (dB)	Measured SAR _{1g} (W/kg)	Scaling Factor	Reported SAR _{1g} (W/kg)	Graph Results
Test Position 1	Low/5736	QPSK	1:1	11	10.71	-0.039	0.0013	1.07	0.001	Figure 7
Test Position 2	Low/5736	QPSK	1:1	11	10.71	0.018	0.018	1.07	0.020	Figure 8
Test Position 3	Low/5736	QPSK	1:1	11	10.71	0.054	0.0015	1.07	0.002	Figure 9
Test Position 4	Low/5736	QPSK	1:1	11	10.71	0.122	0.301	1.07	0.322	Figure 10
Test Position 5	Low/5736	QPSK	1:1	11	10.71	-0.199	0.070	1.07	0.075	Figure 11

Note: 1. The value with blue color is the maximum SAR Value of each test band.

- Per FCC KDB Publication 447498 D01v05, if the reported (scaled) SAR measured at the middle channel or highest output power channel for each test configuration is ≤ 0.8 W/kg then testing at the other channels is not required for such test configuration(s).
- Repeated measurements are not required when the original highest measured SAR is < 0.80 W/kg.

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8. Measurement Uncertainty

No.	source	Type	Uncertainty Value (%)	Probability Distribution	k	c _i	Standard uncertainty u_i (%)	Degree of freedom V_{eff} or v_i
1	System repetivity	A	0.5	N	1	1	0.5	9
Measurement system								
2	-probe calibration	B	6	N	1	1	6.6	∞
3	-axial isotropy of the probe	B	4.7	R	$\sqrt{3}$	$\sqrt{0.5}$	1.9	∞
4	- Hemispherical isotropy of the probe	B	9.4	R	$\sqrt{3}$	$\sqrt{0.5}$	3.9	∞
5	-boundary effect	B	1.9	R	$\sqrt{3}$	1	1.1	∞
6	-probe linearity	B	4.7	R	$\sqrt{3}$	1	2.7	∞
7	- System detection limits	B	1.0	R	$\sqrt{3}$	1	0.6	∞
8	-readout Electronics	B	1.0	N	1	1	1.0	∞
9	-response time	B	0	R	$\sqrt{3}$	1	0	∞
10	-integration time	B	4.3	R	$\sqrt{3}$	1	2.5	∞
11	-noise	B	0	R	$\sqrt{3}$	1	0	∞
12	-RF Ambient Conditions	B	3	R	$\sqrt{3}$	1	1.7	∞
13	-Probe Positioner Mechanical Tolerance	B	0.4	R	$\sqrt{3}$	1	0.2	∞
14	-Probe Positioning with respect to Phantom Shell	B	2.9	R	$\sqrt{3}$	1	1.7	∞
15	-Extrapolation, interpolation and Integration Algorithms for Max. SAR Evaluation	B	3.9	R	$\sqrt{3}$	1	2.3	∞
Test sample Related								
16	-Test Sample Positioning	A	2.9	N	1	1	2.9	71
17	-Device Holder Uncertainty	A	4.1	N	1	1	4.1	5
18	-Output Power Variation - SAR drift measurement	B	5.0	R	$\sqrt{3}$	1	2.9	∞
Physical parameter								
19	-phantom Uncertainty	B	4.0	R	$\sqrt{3}$	1	2.3	∞
20	Algorithm for correcting SAR for deviations in permittivity and conductivity	B	1.9	N	1	0.84	0.9	∞

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21	-Liquid conductivity (measurement uncertainty)	B	2.5	N	1	0.71	1.8	9
22	-Liquid permittivity (measurement uncertainty)	B	2.5	N	1	0.26	0.7	9
23	-Liquid conductivity -temperature uncertainty	B	1.7	R	$\sqrt{3}$	0.71	0.7	∞
24	-Liquid permittivity -temperature uncertainty	B	0.3	R	$\sqrt{3}$	0.26	0.05	∞
Combined standard uncertainty		$u_c' = \sqrt{\sum_{i=1}^{24} c_i^2 u_i^2}$					11.57	
Expanded uncertainty (confidence interval of 95 %)		$u_e = 2u_c$		N	k=2		23.14	

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9. Main Test Instruments

Table 8: List of Main Instruments

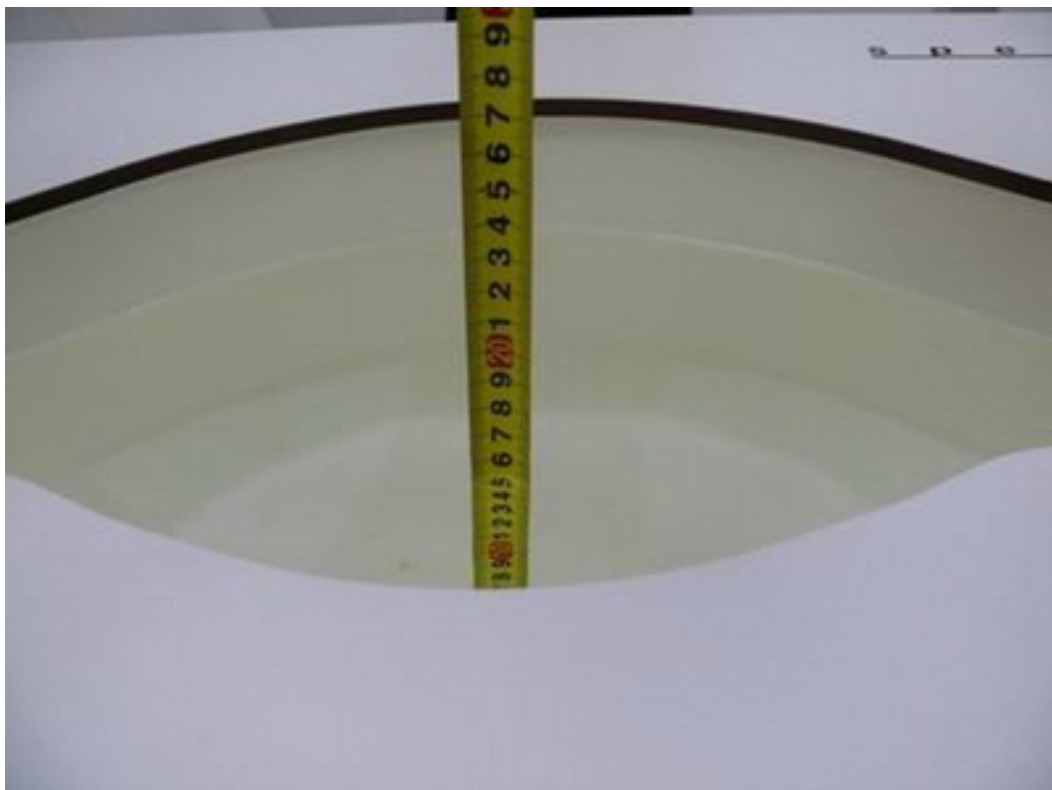
No.	Name	Type	Serial Number	Calibration Date	Valid Period
01	Network analyzer	Agilent 8753E	US37390326	September 11, 2012	One year
02	Dielectric Probe Kit	Agilent 85070E	US44020115	No Calibration Requested	
03	Power meter	Agilent E4417A	GB41291714	March 10, 2013	One year
04	Power sensor	Agilent N8481H	MY50350004	September 24, 2012	One year
05	Power sensor	E9327A	US40441622	January 2, 2013	One year
06	Signal Generator	HP 8341B	2730A00804	September 10, 2012	One year
07	Dual directional coupler	778D-012	50519	March 25, 2013	One year
08	Amplifier	IXA-020	0401	No Calibration Requested	
09	E-field Probe	EX3DV4	3578	June 21, 2012	One year
10	DAE	DAE4	1317	January 25, 2013	One year
11	Validation Kit 5GHz	D5GHzV2	1040	June 19, 2012	One year
12	Temperature Probe	JM222	AA1009129	March 14, 2013	One year
13	Hygrothermograph	WS-1	64591	September 27, 2012	One year

*****END OF REPORT *****

ANNEX A: Test Layout



Picture 1: Specific Absorption Rate Test Layout



Picture 2: Liquid depth in the flat Phantom (5800 MHz, 15.3cm depth)

ANNEX B: System Check Results

System Performance Check at 5800 MHz Body TSL

DUT: Dipole 5 GHz; Type: D5GHzV2; Serial: D5GHzV2 - SN: 1040

Date/Time: 5/14/2013 10:18:17 AM

Communication System: CW; Frequency: 5800 MHz; Duty Cycle: 1:1

Medium parameters used: $f = 5800 \text{ MHz}$; $\sigma = 6.135 \text{ mho/m}$; $\epsilon_r = 47.59$; $\rho = 1000 \text{ kg/m}^3$

Ambient Temperature: 22.3°C Liquid Temperature: 21.5°C

Phantom section: Flat Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: EX3DV4 - SN3578; ConvF(3.43, 3.43, 3.43); Calibrated: 6/21/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: SAM2; Type: SAM; Serial: TP-1524

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

d=10mm, Pin=100mW/Area Scan (41x101x1): Measurement grid: dx=10mm, dy=10mm

Maximum value of SAR (interpolated) = 7.84 mW/g

d=10mm, Pin=100mW/Zoom Scan (6x6x12)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=2mm

Reference Value = 38 V/m; Power Drift = -0.018 dB

Peak SAR (extrapolated) = 22.6 W/kg

SAR(1 g) = 7.1 mW/g; SAR(10 g) = 1.99 mW/g

Maximum value of SAR (measured) = 8.58 mW/g

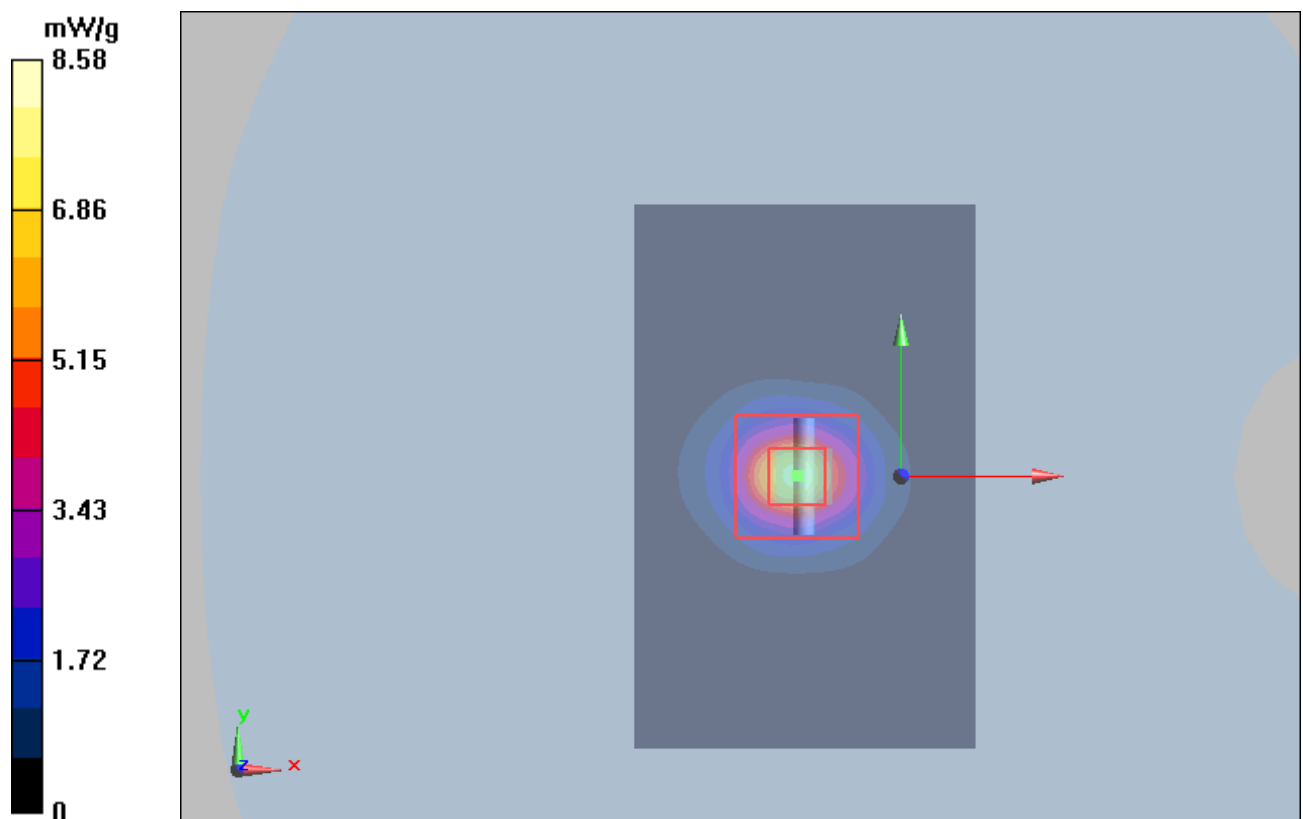


Figure 6 System Performance Check 5800MHz 100mW

ANNEX C: Graph Results

Test Position 1 Low

Date/Time: 5/14/2013 11:53:32 AM

Communication System: 802.11a; Frequency: 5736 MHz; Duty Cycle: 1:1

Medium parameters used: $f = 5736$ MHz; $\sigma = 6.04$ mho/m; $\epsilon_r = 47.8$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: Flat Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: EX3DV4 - SN3578; ConvF(3.43, 3.43, 3.43); Calibrated: 6/21/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: SAM2; Type: SAM; Serial: TP-1524

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

Test Position 1 Low /Area Scan (41x91x1): Measurement grid: dx=10mm, dy=10mm

Maximum value of SAR (interpolated) = 0.014 mW/g

Test Position 1 Low /Zoom Scan (7x7x12)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=2mm

Reference Value = 2.13 V/m; Power Drift = -0.039 dB

Peak SAR (extrapolated) = 0.081 W/kg

SAR(1 g) = 0.0013 mW/g; SAR(10 g) = 9.3e-005 mW/g

Maximum value of SAR (measured) = 0.037 mW/g

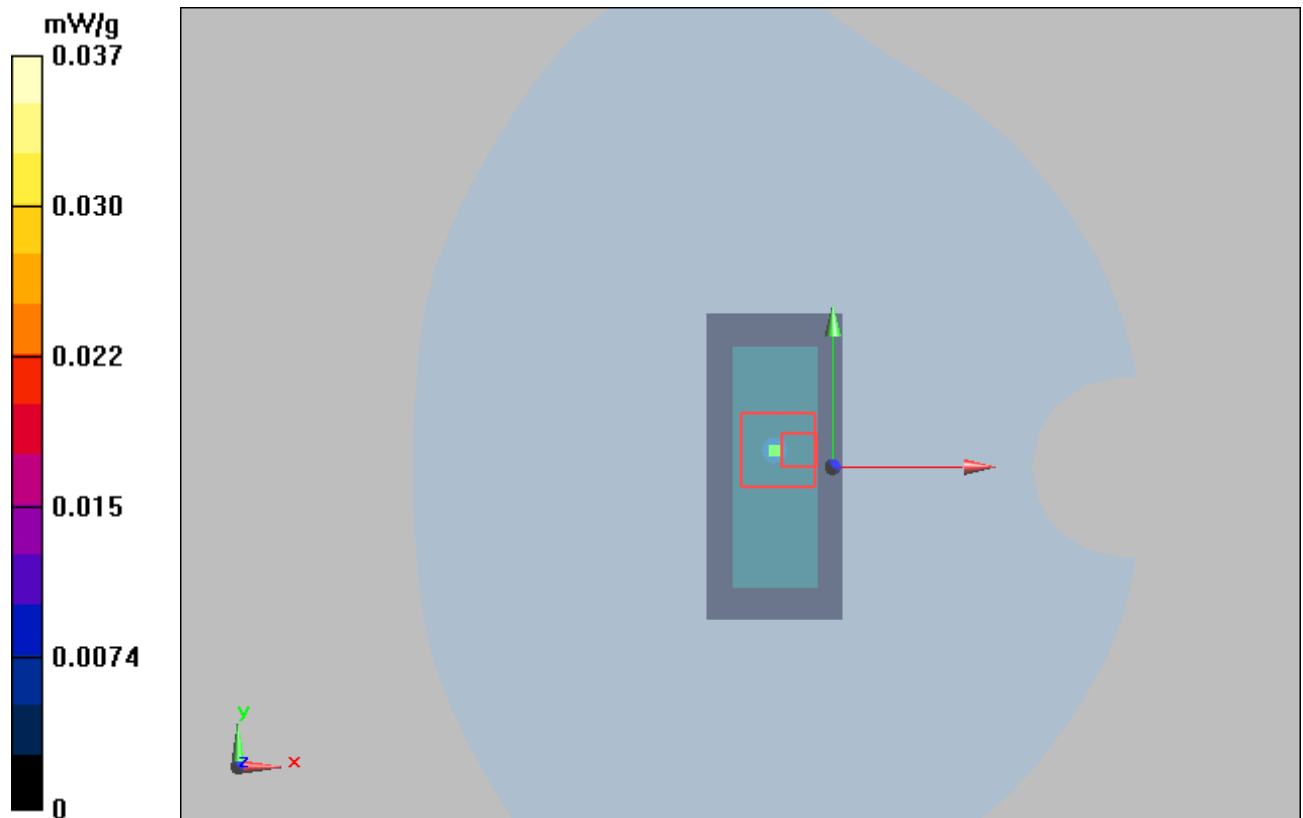


Figure 7 Test Position 1 5736MHz

Test Position 2 Low

Date/Time: 5/14/2013 12:24:38 PM

Communication System: 802.11a; Frequency: 5736 MHz; Duty Cycle: 1:1

Medium parameters used: $f = 5736 \text{ MHz}$; $\sigma = 6.04 \text{ mho/m}$; $\epsilon_r = 47.8$; $\rho = 1000 \text{ kg/m}^3$

Ambient Temperature: 22.3°C Liquid Temperature: 21.5°C

Phantom section: Flat Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: EX3DV4 - SN3578; ConvF(3.43, 3.43, 3.43); Calibrated: 6/21/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: SAM2; Type: SAM; Serial: TP-1524

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

Test Position 2 Low /Area Scan (41x91x1): Measurement grid: $dx=10\text{mm}$, $dy=10\text{mm}$

Maximum value of SAR (interpolated) = 0.094 mW/g

Test Position 2 Low /Zoom Scan (7x7x12)/Cube 0: Measurement grid: $dx=4\text{mm}$, $dy=4\text{mm}$, $dz=2\text{mm}$

Reference Value = 2.53 V/m ; Power Drift = 0.018 dB

Peak SAR (extrapolated) = 0.159 W/kg

SAR(1 g) = 0.018 mW/g ; SAR(10 g) = 0.0041 mW/g

Maximum value of SAR (measured) = 0.051 mW/g

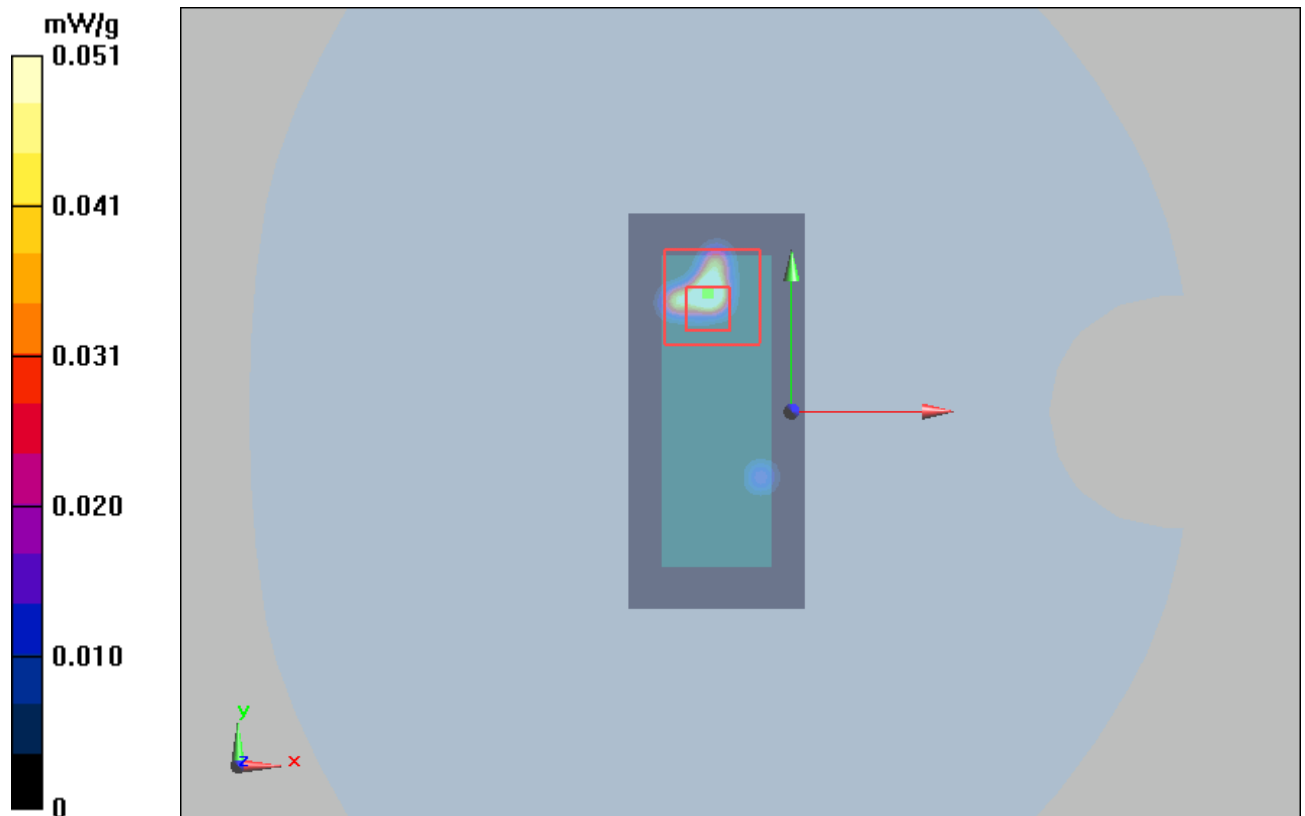


Figure 8 Test Position 2 5736MHz

Test Position 3 Low

Date/Time: 5/14/2013 12:55:12 PM

Communication System: 802.11a; Frequency: 5736 MHz; Duty Cycle: 1:1

Medium parameters used: $f = 5736 \text{ MHz}$; $\sigma = 6.04 \text{ mho/m}$; $\epsilon_r = 47.8$; $\rho = 1000 \text{ kg/m}^3$

Ambient Temperature: 22.3°C Liquid Temperature: 21.5°C

Phantom section: Flat Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: EX3DV4 - SN3578; ConvF(3.43, 3.43, 3.43); Calibrated: 6/21/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: SAM2; Type: SAM; Serial: TP-1524

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

Test Position 3 Low /Area Scan (41x91x1): Measurement grid: $dx=10\text{mm}$, $dy=10\text{mm}$

Maximum value of SAR (interpolated) = 0.00638 mW/g

Test Position 3 Low /Zoom Scan (7x7x12)/Cube 0: Measurement grid: $dx=4\text{mm}$, $dy=4\text{mm}$, $dz=2\text{mm}$

Reference Value = 0.825 V/m ; Power Drift = 0.054 dB

Peak SAR (extrapolated) = 0.087 W/kg

SAR(1 g) = 0.0015 mW/g ; SAR(10 g) = 0.000107 mW/g

Maximum value of SAR (measured) = 0.039 mW/g

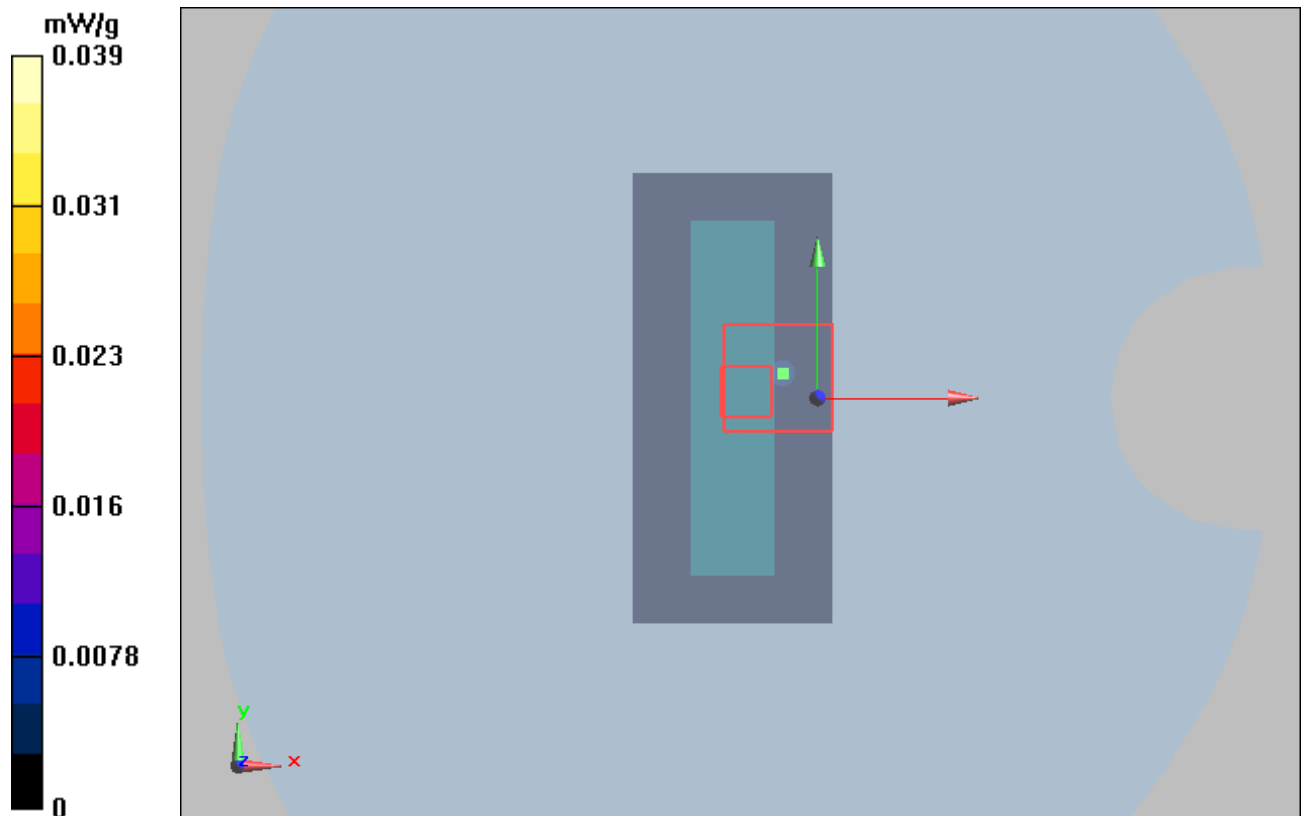


Figure 9 Test Position 3 5736MHz

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Test Position 4 Low

Date/Time: 5/14/2013 2:44:30 PM

Communication System: 802.11a; Frequency: 5736 MHz; Duty Cycle: 1:1

Medium parameters used: $f = 5736 \text{ MHz}$; $\sigma = 6.04 \text{ mho/m}$; $\epsilon_r = 47.8$; $\rho = 1000 \text{ kg/m}^3$

Ambient Temperature: 22.3°C Liquid Temperature: 21.5°C

Phantom section: Flat Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: EX3DV4 - SN3578; ConvF(3.43, 3.43, 3.43); Calibrated: 6/21/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: SAM2; Type: SAM; Serial: TP-1524

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

Test Position 4 Low /Area Scan (41x91x1): Measurement grid: $dx=10\text{mm}$, $dy=10\text{mm}$

Maximum value of SAR (interpolated) = 0.208 mW/g

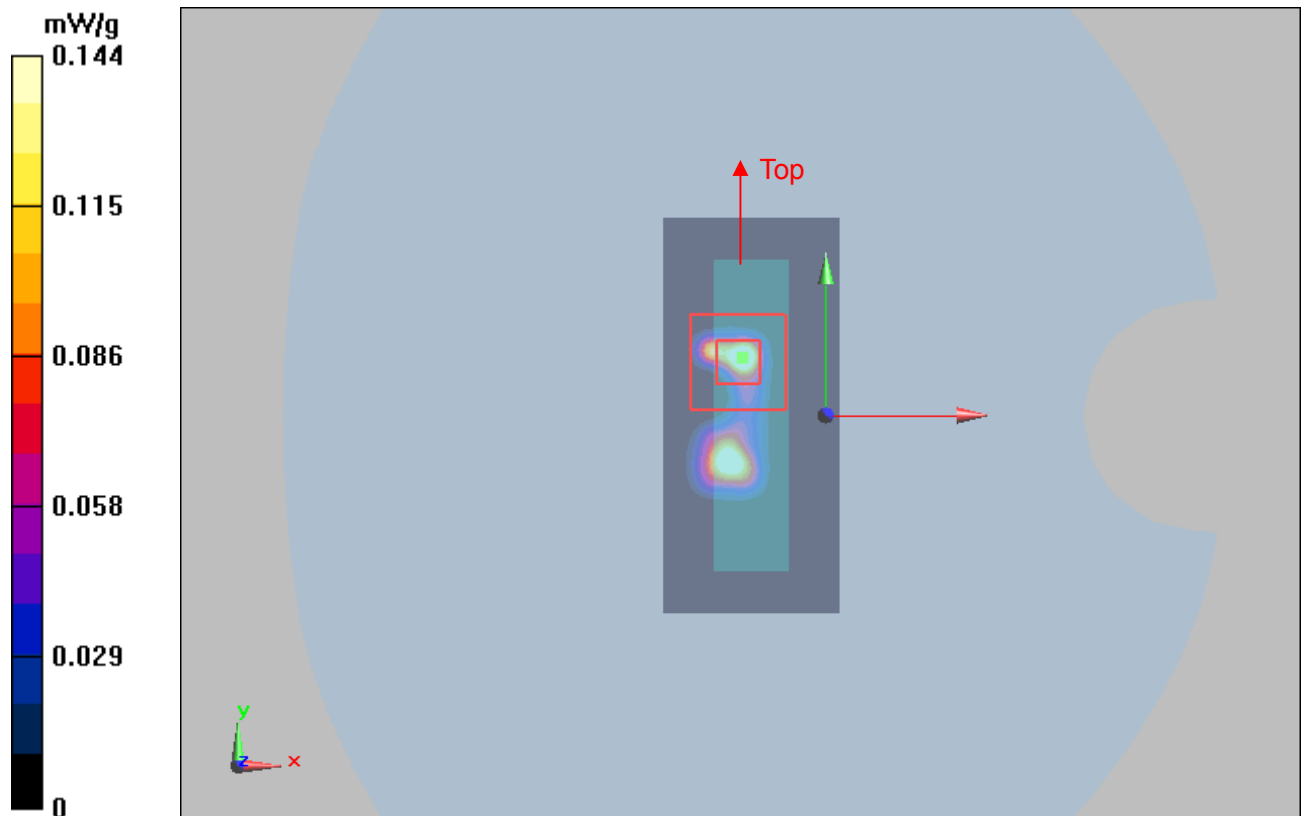
Test Position 4 Low /Zoom Scan (7x7x12)/Cube 0: Measurement grid: $dx=4\text{mm}$, $dy=4\text{mm}$, $dz=2\text{mm}$

Reference Value = 2.66 V/m ; Power Drift = 0.122 dB

Peak SAR (extrapolated) = 4.5 W/kg

SAR(1 g) = 0.301 mW/g ; SAR(10 g) = 0.037 mW/g

Maximum value of SAR (measured) = 0.144 mW/g



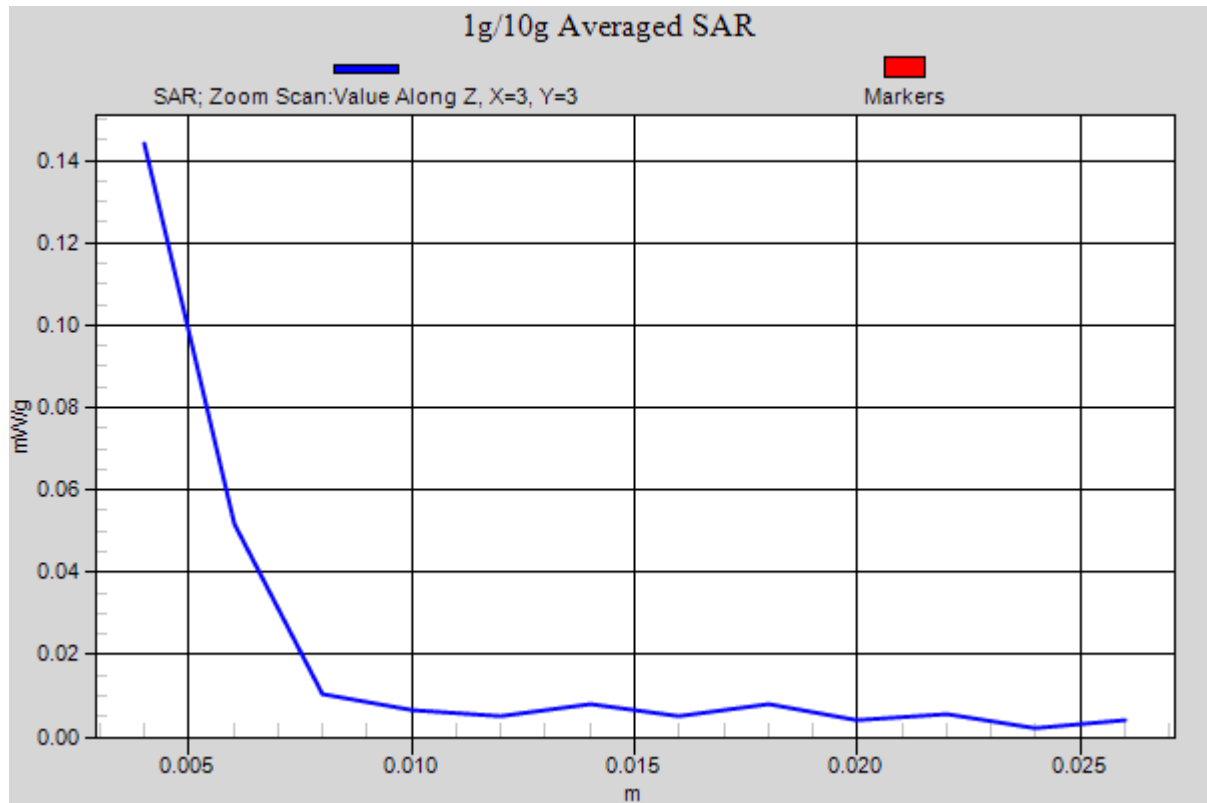


Figure 10 Test Position 4 5736MHz

Test Position 5 Low

Date/Time: 5/14/2013 4:50:11 PM

Communication System: 802.11a; Frequency: 5736 MHz; Duty Cycle: 1:1

Medium parameters used: $f = 5736 \text{ MHz}$; $\sigma = 6.04 \text{ mho/m}$; $\epsilon_r = 47.8$; $\rho = 1000 \text{ kg/m}^3$

Ambient Temperature: 22.3°C Liquid Temperature: 21.5°C

Phantom section: Flat Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: EX3DV4 - SN3578; ConvF(3.43, 3.43, 3.43); Calibrated: 6/21/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: SAM2; Type: SAM; Serial: TP-1524

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

Test Position 5 Low /Area Scan (41x51x1): Measurement grid: $dx=10\text{mm}$, $dy=10\text{mm}$

Maximum value of SAR (interpolated) = 0.093 mW/g

Test Position 5 Low /Zoom Scan (7x7x12)/Cube 0: Measurement grid: $dx=4\text{mm}$, $dy=4\text{mm}$, $dz=2\text{mm}$

Reference Value = 3.6 V/m ; Power Drift = -0.199 dB

Peak SAR (extrapolated) = 1.56 W/kg

SAR(1 g) = 0.070 mW/g ; SAR(10 g) = 0.00725 mW/g

Maximum value of SAR (measured) = 0.056 mW/g

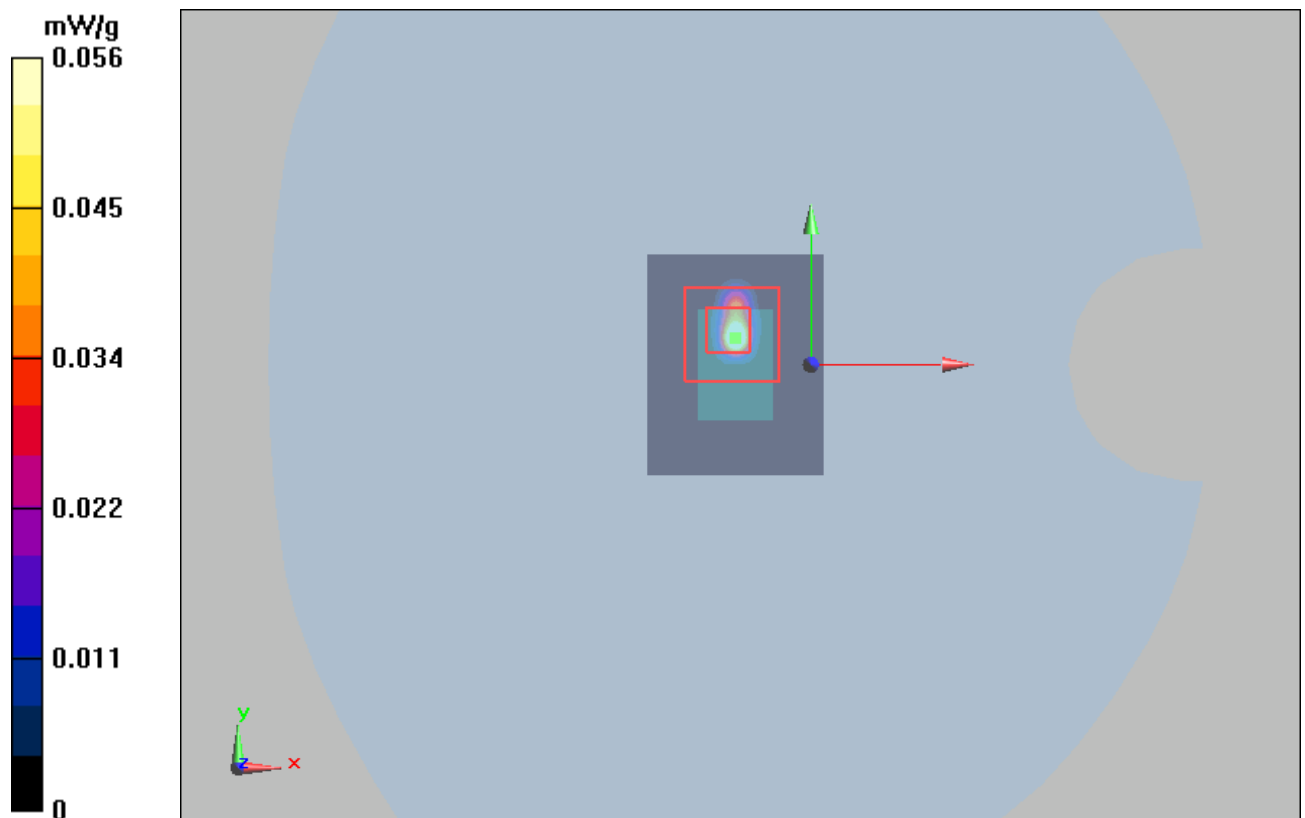


Figure 11 Test Position 5 5736MHz

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ANNEX D: Probe Calibration Certificate

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **Auden**

Certificate No: **EX3-3578_Jun12**

CALIBRATION CERTIFICATE

Object **EX3DV4 - SN:3578**

Calibration procedure(s) **QA CAL-01.v8, QA CAL-14.v3, QA CAL-23.v4, QA CAL-25.v4**
Calibration procedure for dosimetric E-field probes

Calibration date: **June 21, 2012**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature $(22 \pm 3)^{\circ}\text{C}$ and humidity $< 70\%$.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	29-Mar-12 (No. 217-01508)	Apr-13
Power sensor E4412A	MY41498087	29-Mar-12 (No. 217-01508)	Apr-13
Reference 3 dB Attenuator	SN: S5054 (3c)	27-Mar-12 (No. 217-01531)	Apr-13
Reference 20 dB Attenuator	SN: S5086 (20b)	27-Mar-12 (No. 217-01529)	Apr-13
Reference 30 dB Attenuator	SN: S5129 (30b)	27-Mar-12 (No. 217-01532)	Apr-13
Reference Probe ES3DV2	SN: 3013	29-Dec-11 (No. ES3-3013_Dec11)	Dec-12
DAE4	SN: 660	10-Jan-12 (No. DAE4-660_Jan12)	Jan-13
Secondary Standards	ID	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642U01700	4-Aug-99 (in house check Apr-11)	In house check: Apr-13
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-11)	In house check: Oct-12

	Name	Function	Signature
Calibrated by:	Jeton Kastrati	Laboratory Technician	
Approved by:	Katja Pokovic	Technical Manager	
Issued: June 22, 2012			
This calibration certificate shall not be reproduced except in full without written approval of the laboratory.			

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Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



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S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 108

Glossary:

TSL	tissue simulating liquid
NORM _{x,y,z}	sensitivity in free space
ConvF	sensitivity in TSL / NORM _{x,y,z}
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C	modulation dependent linearization parameters
Polarization ϕ	ϕ rotation around probe axis
Polarization θ	θ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\theta = 0$ is normal to probe axis

Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

Methods Applied and Interpretation of Parameters:

- NORM_{x,y,z}: Assessed for E-field polarization $\theta = 0$ ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide). NORM_{x,y,z} are only intermediate values, i.e., the uncertainties of NORM_{x,y,z} does not affect the E²-field uncertainty inside TSL (see below ConvF).
- NORM(f)_{x,y,z} = NORM_{x,y,z} * frequency_response (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCP_{x,y,z}: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- A_{x,y,z}; B_{x,y,z}; C_{x,y,z}; VR_{x,y,z}: A, B, C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters: Assessed in flat phantom using E-field (or Temperature Transfer Standard for $f \leq 800$ MHz) and inside waveguide using analytical field distributions based on power measurements for $f > 800$ MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORM_{x,y,z} * ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- Spherical isotropy (3D deviation from isotropy): in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.

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EX3DV4 – SN:3578

June 21, 2012

Probe EX3DV4

SN:3578

Manufactured: November 4, 2005
Calibrated: June 21, 2012

Calibrated for DASY/EASY Systems
(Note: non-compatible with DASY2 system!)

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EX3DV4- SN:3578

June 21, 2012

DASY/EASY - Parameters of Probe: EX3DV4 - SN:3578

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm ($\mu V/(V/m)^2$) ^A	0.53	0.50	0.55	$\pm 10.1 \%$
DCP (mV) ^B	102.4	101.5	103.4	

Modulation Calibration Parameters

UID	Communication System Name	PAR		A dB	B dB	C dB	VR mV	Unc ^E (k=2)
0	CW	0.00	X	0.00	0.00	1.00	166.9	$\pm 2.2 \%$
			Y	0.00	0.00	1.00	173.1	
			Z	0.00	0.00	1.00	178.2	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor $k=2$, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^A The uncertainties of NormX,Y,Z do not affect the E^2 -field uncertainty inside TSL (see Pages 5 and 6).

^B Numerical linearization parameter: uncertainty not required.

^E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

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EX3DV4– SN:3578

June 21, 2012

DASY/EASY - Parameters of Probe: EX3DV4 - SN:3578

Calibration Parameter Determined in Head Tissue Simulating Media

f (MHz) ^C	Relative Permittivity ^F	Conductivity (S/m) ^F	ConvF X	ConvF Y	ConvF Z	Alpha	Depth (mm)	Unct. (k=2)
750	41.9	0.89	8.77	8.77	8.77	0.80	0.64	± 12.0 %
835	41.5	0.90	8.30	8.30	8.30	0.29	0.99	± 12.0 %
900	41.5	0.97	8.35	8.35	8.35	0.58	0.75	± 12.0 %
1750	40.1	1.37	7.50	7.50	7.50	0.80	0.62	± 12.0 %
1900	40.0	1.40	7.19	7.19	7.19	0.75	0.65	± 12.0 %
2000	40.0	1.40	7.13	7.13	7.13	0.77	0.58	± 12.0 %
2450	39.2	1.80	6.43	6.43	6.43	0.28	1.01	± 12.0 %
5200	36.0	4.66	4.55	4.55	4.55	0.40	1.80	± 13.1 %
5300	35.9	4.76	4.39	4.39	4.39	0.40	1.80	± 13.1 %
5500	35.6	4.96	4.07	4.07	4.07	0.50	1.80	± 13.1 %
5600	35.5	5.07	3.92	3.92	3.92	0.50	1.80	± 13.1 %
5800	35.3	5.27	3.72	3.72	3.72	0.55	1.80	± 13.1 %

^C Frequency validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2), else it is restricted to ± 50 MHz. The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

^F At frequencies below 3 GHz, the validity of tissue parameters (ϵ and σ) can be relaxed to ± 10% if liquid compensation formula is applied to measured SAR values. At frequencies above 3 GHz, the validity of tissue parameters (ϵ and σ) is restricted to ± 5%. The uncertainty is the RSS of the ConvF uncertainty for indicated target tissue parameters.

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EX3DV4- SN:3578

June 21, 2012

DASY/EASY - Parameters of Probe: EX3DV4 - SN:3578

Calibration Parameter Determined in Body Tissue Simulating Media

f (MHz) ^C	Relative Permittivity ^F	Conductivity (S/m) ^F	ConvF X	ConvF Y	ConvF Z	Alpha	Depth (mm)	Unct. (k=2)
750	55.5	0.96	8.52	8.52	8.52	0.42	0.88	± 12.0 %
835	55.2	0.97	8.45	8.45	8.45	0.32	1.06	± 12.0 %
900	55.0	1.05	8.33	8.33	8.33	0.36	0.95	± 12.0 %
1750	53.4	1.49	7.10	7.10	7.10	0.39	0.89	± 12.0 %
1900	53.3	1.52	6.69	6.69	6.69	0.69	0.68	± 12.0 %
2000	53.3	1.52	6.86	6.86	6.86	0.70	0.67	± 12.0 %
2450	52.7	1.95	6.43	6.43	6.43	0.80	0.50	± 12.0 %
5200	49.0	5.30	3.93	3.93	3.93	0.50	1.90	± 13.1 %
5300	48.9	5.42	3.66	3.66	3.66	0.50	1.90	± 13.1 %
5500	48.6	5.65	3.45	3.45	3.45	0.55	1.90	± 13.1 %
5600	48.5	5.77	3.25	3.25	3.25	0.55	1.90	± 13.1 %
5800	48.2	6.00	3.43	3.43	3.43	0.55	1.90	± 13.1 %

^C Frequency validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2), else it is restricted to ± 50 MHz. The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

^F At frequencies below 3 GHz, the validity of tissue parameters (ϵ and σ) can be relaxed to ± 10% if liquid compensation formula is applied to measured SAR values. At frequencies above 3 GHz, the validity of tissue parameters (ϵ and σ) is restricted to ± 5%. The uncertainty is the RSS of the ConvF uncertainty for indicated target tissue parameters.

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Test Report

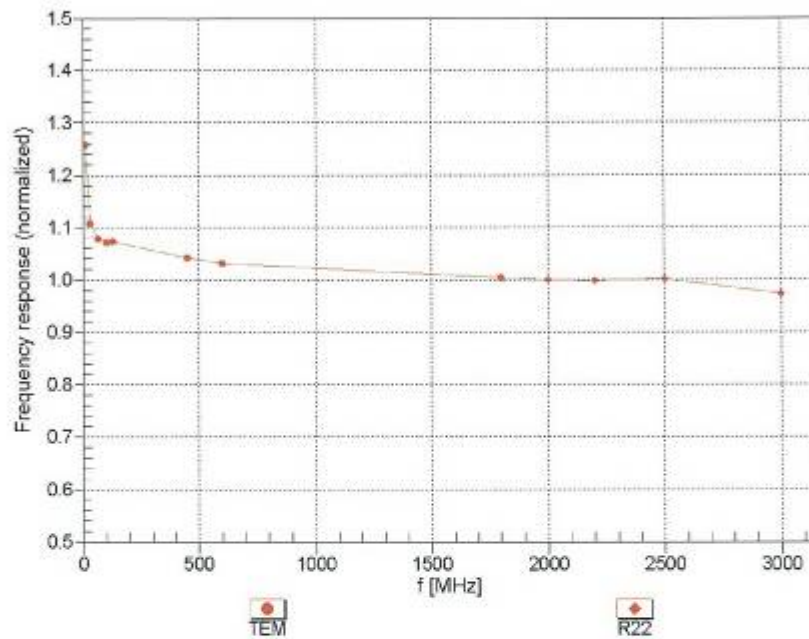
Report No. RXA1303-0334SAR01R1

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EX3DV4- SN:3578

June 21, 2012

Frequency Response of E-Field
(TEM-Cell: ifi110 EXX, Waveguide: R22)



Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ ($k=2$)

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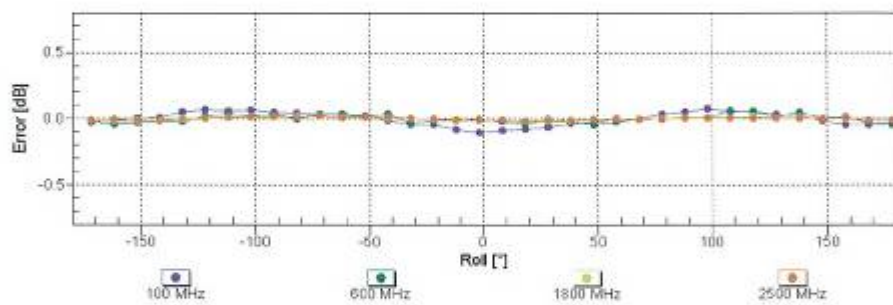
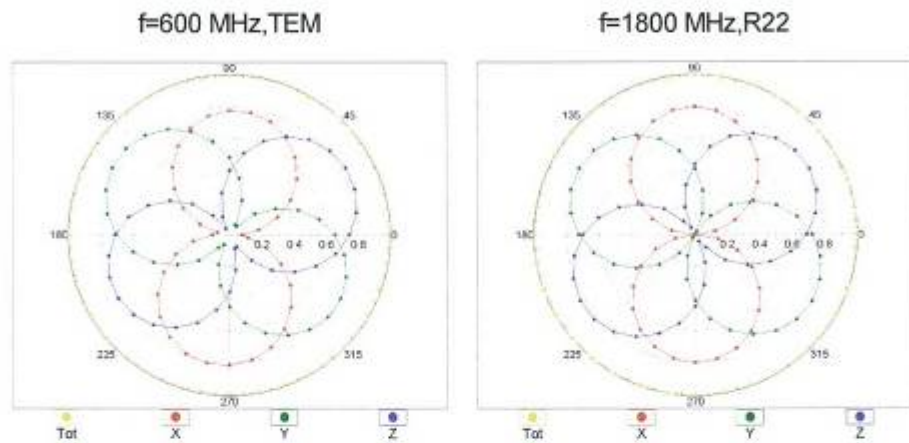
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EX3DV4-SN:3578

June 21, 2012

Receiving Pattern (ϕ), $\theta = 0^\circ$



Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)

TA Technology (Shanghai) Co., Ltd. Test Report

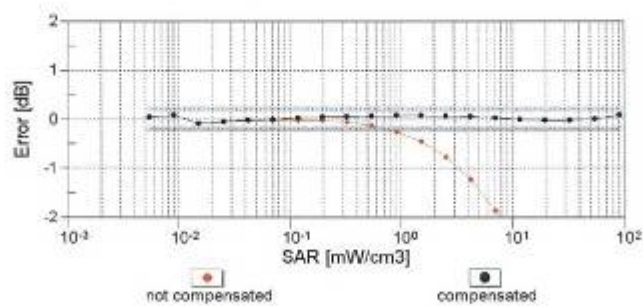
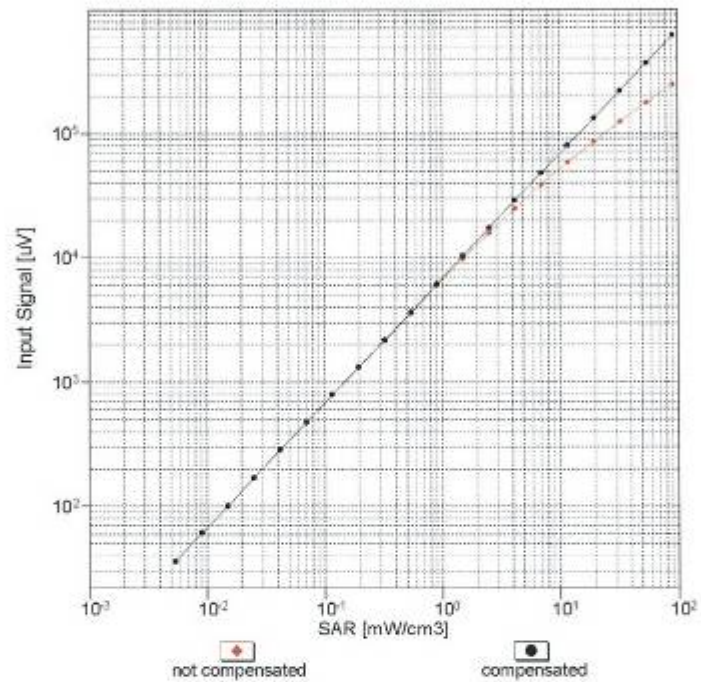
Report No. RXA1303-0334SAR01R1

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EX3DV4- SN:3578

June 21, 2012

Dynamic Range f(SAR_{head}) (TEM cell , f = 900 MHz)

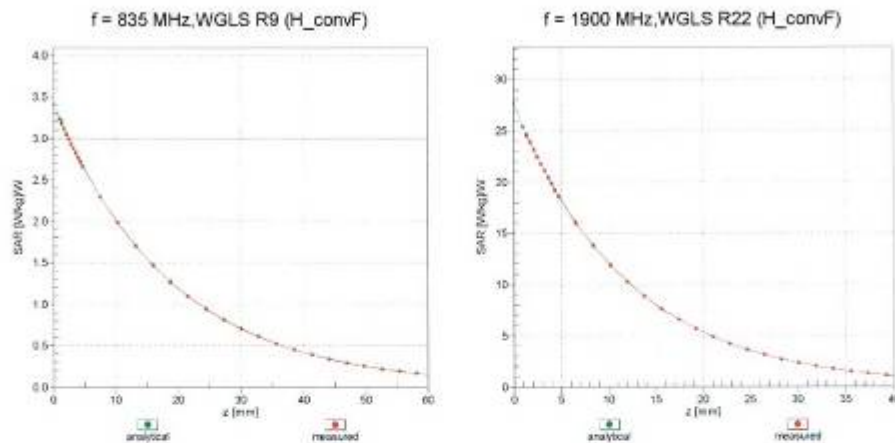


Uncertainty of Linearity Assessment: $\pm 0.6\%$ ($k=2$)

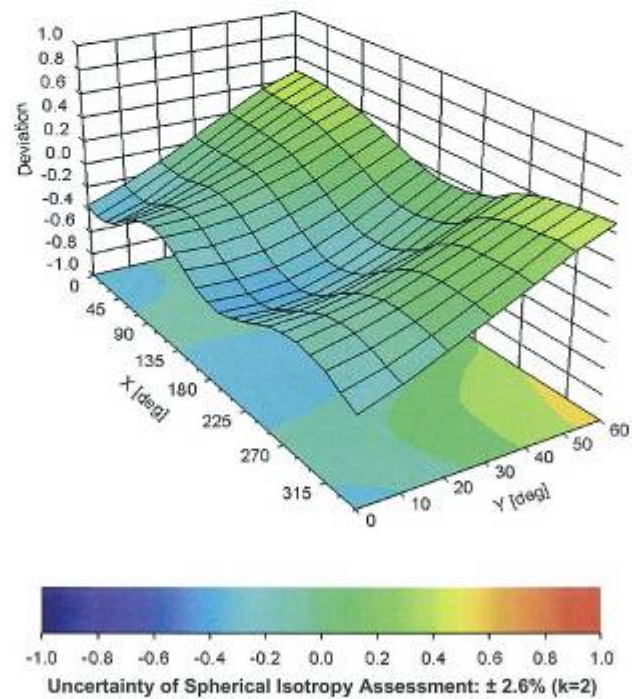
EX3DV4- SN:3578

June 21, 2012

Conversion Factor Assessment



Deviation from Isotropy in Liquid Error (ϕ, θ), $f = 900 \text{ MHz}$



TA Technology (Shanghai) Co., Ltd.
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EX3DV4- SN:3578

June 21, 2012

DASY/EASY - Parameters of Probe: EX3DV4 - SN:3578

Other Probe Parameters

Sensor Arrangement	Triangular
Connector Angle (°)	68.2
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	9 mm
Tip Diameter	2.5 mm
Probe Tip to Sensor X Calibration Point	1 mm
Probe Tip to Sensor Y Calibration Point	1 mm
Probe Tip to Sensor Z Calibration Point	1 mm
Recommended Measurement Distance from Surface	2 mm

TA Technology (Shanghai) Co., Ltd.

Test Report

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ANNEX E: D5GHzV2 Dipole Calibration Certificate

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **Auden**

Certificate No: **D5GHzV2-1040_Jun12**

CALIBRATION CERTIFICATE

Object **D5GHzV2 - SN: 1040**

Calibration procedure(s) **QA CAL-22.v1**
Calibration procedure for dipole validation kits between 3-6 GHz

Calibration date: **June 19, 2012**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	05-Oct-11 (No. 217-01451)	Oct-12
Power sensor HP 8481A	US37292783	05-Oct-11 (No. 217-01451)	Oct-12
Reference 20 dB Attenuator	SN: 5058 (20k)	27-Mar-12 (No. 217-01530)	Apr-13
Type-N mismatch combination	SN: 5047.2 / 06327	27-Mar-12 (No. 217-01533)	Apr-13
Reference Probe EX3DV4	SN: 3503	30-Dec-11 (No. EX3-3503_Dec11)	Dec-12
DAE4	SN: 601	04-Jul-11 (No. DAE4-601_Jul11)	Jul-12
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power sensor HP 8481A	MY41092317	18-Oct-02 (in house check Oct-11)	In house check: Oct-13
RF generator R&S SMT-06	100005	04-Aug-99 (in house check Oct-11)	In house check: Oct-13
Network Analyzer HP 8753E	US37390585 S4206	18-Oct-01 (in house check Oct-11)	In house check: Oct-12

	Name	Function	Signature
Calibrated by:	Dimce Iliev	Laboratory Technician	
Approved by:	Katja Pokovic	Technical Manager	

Issued: June 20, 2012

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

TA Technology (Shanghai) Co., Ltd.

Test Report

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Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Glossary:

TSL	tissue simulating liquid
ConvF	sensitivity in TSL / NORM x,y,z
N/A	not applicable or not measured

Calibration is Performed According to the Following Standards:

- IEC 62209-2, "Evaluation of Human Exposure to Radio Frequency Fields from Handheld and Body-Mounted Wireless Communication Devices in the Frequency Range of 30 MHz to 6 GHz: Human models, Instrumentation, and Procedures"; Part 2: "Procedure to determine the Specific Absorption Rate (SAR) for including accessories and multiple transmitters", March 2010
- Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

Additional Documentation:

- DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions:** Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL:** The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss:** These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay:** One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured:** SAR measured at the stated antenna input power.
- SAR normalized:** SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters:** The measured TSL parameters are used to calculate the nominal SAR result.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor $k=2$, which for a normal distribution corresponds to a coverage probability of approximately 95%.

TA Technology (Shanghai) Co., Ltd.

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.8.1
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom V5.0	
Distance Dipole Center - TSL	10 mm	with Spacer
Zoom Scan Resolution	dx, dy = 4.0 mm, dz = 1.4 mm	Graded Ratio = 1.4 (Z direction)
Frequency	5200 MHz \pm 1 MHz 5500 MHz \pm 1 MHz 5800 MHz \pm 1 MHz	

Head TSL parameters at 5200 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	36.0	4.66 mho/m
Measured Head TSL parameters	(22.0 \pm 0.2) °C	35.0 \pm 6 %	4.52 mho/m \pm 6 %
Head TSL temperature change during test	< 0.5 °C	----	----

SAR result with Head TSL at 5200 MHz

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	100 mW input power	8.20 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	81.5 mW / g \pm 19.9 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR measured	100 mW input power	2.36 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	23.4 mW / g \pm 19.5 % (k=2)

Head TSL parameters at 5500 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	35.6	4.96 mho/m
Measured Head TSL parameters	(22.0 \pm 0.2) °C	34.6 \pm 6 %	4.80 mho/m \pm 6 %
Head TSL temperature change during test	< 0.5 °C	----	----

SAR result with Head TSL at 5500 MHz

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	100 mW input power	8.82 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	87.5 mW / g \pm 19.9 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR measured	100 mW input power	2.52 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	25.0 mW / g \pm 19.5 % (k=2)

TA Technology (Shanghai) Co., Ltd.

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Head TSL parameters at 5800 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	35.3	5.27 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	34.1 ± 6 %	5.11 mho/m ± 6 %
Head TSL temperature change during test	< 0.5 °C	----	----

SAR result with Head TSL at 5800 MHz

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	100 mW input power	8.23 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	81.6 mW / g ± 19.9 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR measured	100 mW input power	2.35 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	23.3 mW / g ± 19.5 % (k=2)

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Body TSL parameters at 5200 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	49.0	5.30 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) °C	47.0 ± 6 %	5.37 mho/m ± 6 %
Body TSL temperature change during test	< 0.5 °C	----	----

SAR result with Body TSL at 5200 MHz

SAR averaged over 1 cm ³ (1 g) of Body TSL	Condition	
SAR measured	100 mW input power	7.37 mW / g
SAR for nominal Body TSL parameters	normalized to 1W	73.1 mW / g ± 19.9 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Body TSL	condition	
SAR measured	100 mW input power	2.07 mW / g
SAR for nominal Body TSL parameters	normalized to 1W	20.5 mW / g ± 19.5 % (k=2)

Body TSL parameters at 5500 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	48.6	5.65 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) °C	46.5 ± 6 %	5.76 mho/m ± 6 %
Body TSL temperature change during test	< 0.5 °C	----	----

SAR result with Body TSL at 5500 MHz

SAR averaged over 1 cm ³ (1 g) of Body TSL	Condition	
SAR measured	100 mW input power	7.87 mW / g
SAR for nominal Body TSL parameters	normalized to 1W	78.1 mW / g ± 19.9 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Body TSL	condition	
SAR measured	100 mW input power	2.19 mW / g
SAR for nominal Body TSL parameters	normalized to 1W	21.7 mW / g ± 19.5 % (k=2)

TA Technology (Shanghai) Co., Ltd.

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Body TSL parameters at 5800 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	48.2	6.00 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) °C	46.0 ± 6 %	6.16 mho/m ± 6 %
Body TSL temperature change during test	< 0.5 °C	----	----

SAR result with Body TSL at 5800 MHz

SAR averaged over 1 cm ³ (1 g) of Body TSL	Condition	
SAR measured	100 mW input power	7.44 mW / g
SAR for nominal Body TSL parameters	normalized to 1W	73.8 mW / g ± 19.9 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Body TSL	condition	
SAR measured	100 mW input power	2.06 mW / g
SAR for nominal Body TSL parameters	normalized to 1W	20.4 mW / g ± 19.5 % (k=2)

TA Technology (Shanghai) Co., Ltd.

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Appendix

Antenna Parameters with Head TSL at 5200 MHz

Impedance, transformed to feed point	49.2 Ω - 7.1 j Ω
Return Loss	- 22.8 dB

Antenna Parameters with Head TSL at 5500 MHz

Impedance, transformed to feed point	51.5 Ω - 4.4 j Ω
Return Loss	- 26.8 dB

Antenna Parameters with Head TSL at 5800 MHz

Impedance, transformed to feed point	55.3 Ω - 2.7 j Ω
Return Loss	- 24.9 dB

Antenna Parameters with Body TSL at 5200 MHz

Impedance, transformed to feed point	49.6 Ω - 5.5 j Ω
Return Loss	- 25.2 dB

Antenna Parameters with Body TSL at 5500 MHz

Impedance, transformed to feed point	52.5 Ω - 3.2 j Ω
Return Loss	- 28.1 dB

Antenna Parameters with Body TSL at 5800 MHz

Impedance, transformed to feed point	56.6 Ω - 1.3 j Ω
Return Loss	- 24.0 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.202 ns
----------------------------------	----------

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals. On some of the dipoles, small end caps are added to the dipole arms in order to improve matching when loaded according to the position as explained in the "Measurement Conditions" paragraph. The SAR data are not affected by this change. The overall dipole length is still according to the Standard.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
Manufactured on	December 30, 2005

DASY5 Validation Report for Head TSL

Date: 19.06.2012

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 5GHz; Type: D5GHzV2; Serial: D5GHzV2 - SN: 1040

Communication System: CW; Frequency: 5200 MHz, Frequency: 5500 MHz, Frequency: 5800 MHz
Medium parameters used: $f = 5200$ MHz; $\sigma = 4.52$ mho/m; $\epsilon_r = 35$; $\rho = 1000$ kg/m³, Medium parameters used: $f = 5500$ MHz; $\sigma = 4.8$ mho/m; $\epsilon_r = 34.6$; $\rho = 1000$ kg/m³, Medium parameters used: $f = 5800$ MHz; $\sigma = 5.11$ mho/m; $\epsilon_r = 34.1$; $\rho = 1000$ kg/m³
Phantom section: Flat Section
Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY52 Configuration:

- Probe: EX3DV4 - SN3503; ConvF(5.41, 5.41, 5.41); Calibrated: 30.12.2011, ConvF(4.91, 4.91, 4.91); Calibrated: 30.12.2011, ConvF(4.81, 4.81, 4.81); Calibrated: 30.12.2011;
- Sensor-Surface: 1.4mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 04.07.2011
- Phantom: Flat Phantom 5.0 (front); Type: QD000P50AA; Serial: 1001
- DASY52 52.8.1(838); SEMCAD X 14.6.5(6469)

Dipole Calibration for Head Tissue/Pin=100mW, dist=10mm, f=5200 MHz/Zoom Scan, dist=1.4mm (8x8x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm
Reference Value = 65.507 V/m; Power Drift = 0.02 dB
Peak SAR (extrapolated) = 30.371 mW/g
SAR(1 g) = 8.2 mW/g; SAR(10 g) = 2.36 mW/g
Maximum value of SAR (measured) = 19.0 mW/g

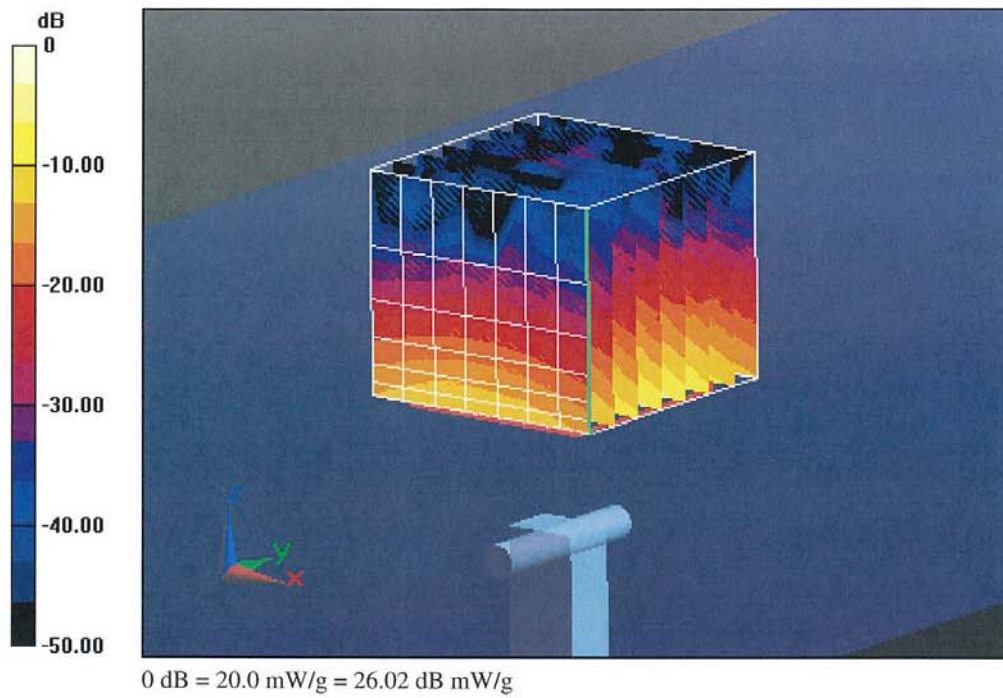
Dipole Calibration for Head Tissue/Pin=100mW, dist=10mm, f=5500 MHz/Zoom Scan, dist=1.4mm (8x8x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm
Reference Value = 66.096 V/m; Power Drift = 0.05 dB
Peak SAR (extrapolated) = 35.013 mW/g
SAR(1 g) = 8.82 mW/g; SAR(10 g) = 2.52 mW/g
Maximum value of SAR (measured) = 21.2 mW/g

Dipole Calibration for Head Tissue/Pin=100mW, dist=10mm, f=5800 MHz/Zoom Scan, dist=1.4mm (8x8x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm
Reference Value = 62.419 V/m; Power Drift = 0.07 dB
Peak SAR (extrapolated) = 34.147 mW/g
SAR(1 g) = 8.23 mW/g; SAR(10 g) = 2.35 mW/g
Maximum value of SAR (measured) = 20.0 mW/g

TA Technology (Shanghai) Co., Ltd.
Test Report

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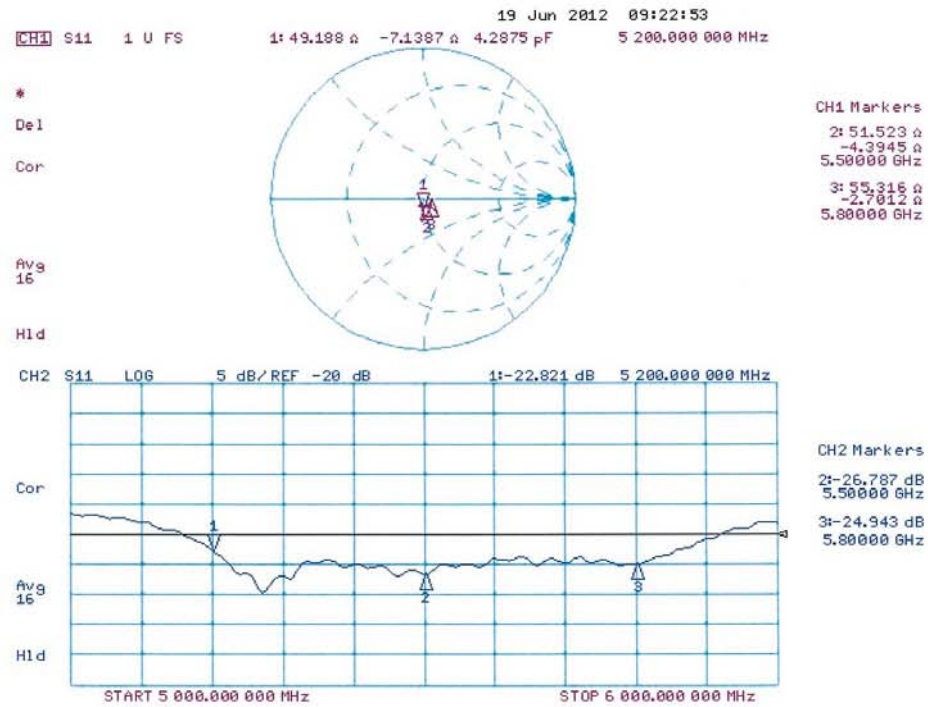
TA Technology (Shanghai) Co., Ltd.

Test Report

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Impedance Measurement Plot for Head TSL



TA Technology (Shanghai) Co., Ltd.

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DASY5 Validation Report for Body TSL

Date: 18.06.2012

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 5GHz; Type: D5GHzV2; Serial: D5GHzV2 - SN: 1040

Communication System: CW; Frequency: 5200 MHz, Frequency: 5500 MHz, Frequency: 5800 MHz
Medium parameters used: $f = 5200$ MHz; $\sigma = 5.37$ mho/m; $\epsilon_r = 47$; $\rho = 1000$ kg/m³, Medium parameters used: $f = 5500$ MHz; $\sigma = 5.76$ mho/m; $\epsilon_r = 46.5$; $\rho = 1000$ kg/m³, Medium parameters used: $f = 5800$ MHz; $\sigma = 6.16$ mho/m; $\epsilon_r = 46$; $\rho = 1000$ kg/m³
Phantom section: Flat Section
Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY52 Configuration:

- Probe: EX3DV4 - SN3503; ConvF(4.91, 4.91, 4.91); Calibrated: 30.12.2011, ConvF(4.43, 4.43, 4.43); Calibrated: 30.12.2011, ConvF(4.38, 4.38, 4.38); Calibrated: 30.12.2011;
- Sensor-Surface: 1.4mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 04.07.2011
- Phantom: Flat Phantom 5.0 (back); Type: QD000P50AA; Serial: 1002
- DASY52 52.8.1(838); SEMCAD X 14.6.5(6469)

Dipole Calibration for Body Tissue/Pin=100mW, dist=10mm, f=5200 MHz/Zoom Scan, dist=1.4mm (8x8x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm
Reference Value = 58.667 V/m; Power Drift = -0.05 dB
Peak SAR (extrapolated) = 29.022 mW/g
SAR(1 g) = 7.37 mW/g; SAR(10 g) = 2.07 mW/g
Maximum value of SAR (measured) = 17.2 mW/g

Dipole Calibration for Body Tissue/Pin=100mW, dist=10mm, f=5500 MHz/Zoom Scan, dist=1.4mm (8x8x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm
Reference Value = 58.708 V/m; Power Drift = -0.02 dB
Peak SAR (extrapolated) = 33.769 mW/g
SAR(1 g) = 7.87 mW/g; SAR(10 g) = 2.19 mW/g
Maximum value of SAR (measured) = 19.0 mW/g

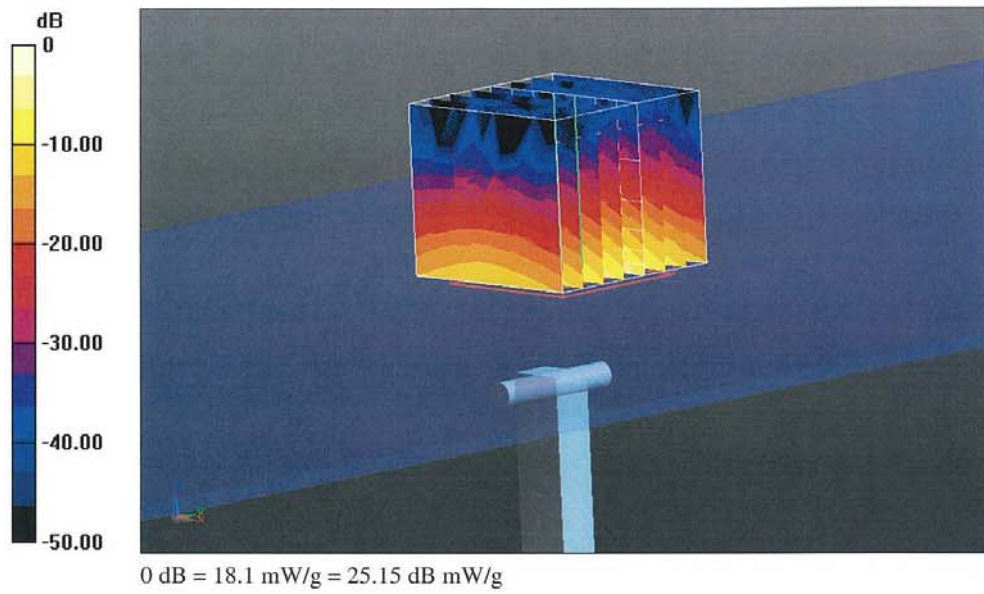
Dipole Calibration for Body Tissue/Pin=100mW, dist=10mm, f=5800 MHz/Zoom Scan, dist=1.4mm (8x8x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm
Reference Value = 55.529 V/m; Power Drift = 0.02 dB
Peak SAR (extrapolated) = 34.868 mW/g
SAR(1 g) = 7.44 mW/g; SAR(10 g) = 2.06 mW/g
Maximum value of SAR (measured) = 18.1 mW/g

TA Technology (Shanghai) Co., Ltd.

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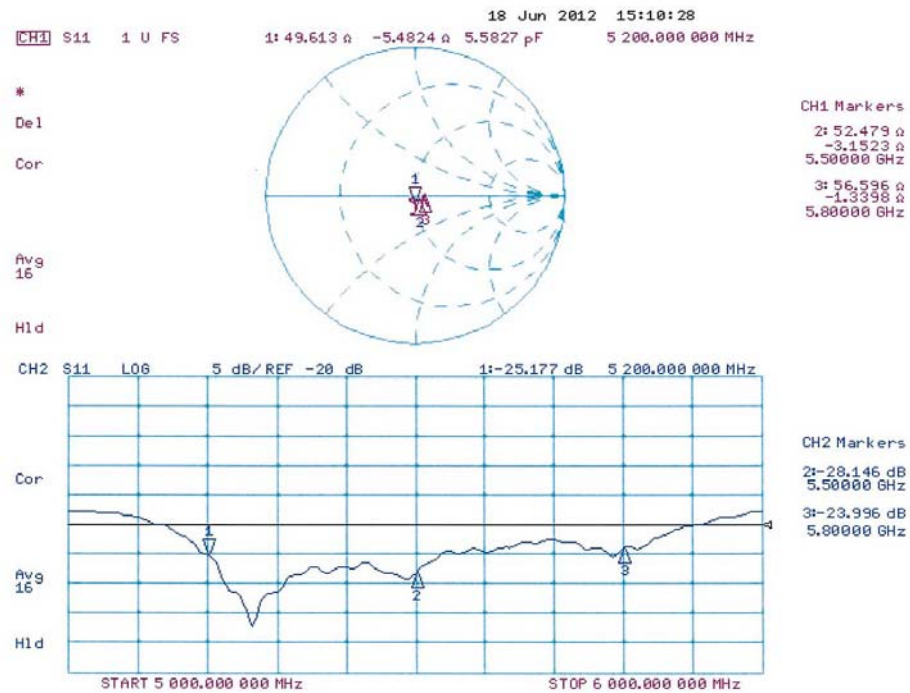


TA Technology (Shanghai) Co., Ltd. Test Report

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Impedance Measurement Plot for Body TSL



TA Technology (Shanghai) Co., Ltd.
Test Report

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ANNEX F: DAE4 Calibration Certificate

**Calibration Laboratory of
Schmid & Partner
Engineering AG**
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **TA Shanghai (Auden)**

Certificate No: **DAE4-1317_Jan13**

CALIBRATION CERTIFICATE

Object **DAE4 - SD 000 D04 BJ - SN: 1317**

Calibration procedure(s) **QA CAL-06.v25
Calibration procedure for the data acquisition electronics (DAE)**

Calibration date: **January 25, 2013**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature $(22 \pm 3)^{\circ}\text{C}$ and humidity $< 70\%$.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Keithley Multimeter Type 2001	SN: 0810278	02-Oct-12 (No:12728)	Oct-13
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Auto DAE Calibration Unit	SE UWS 053 AA 1001	07-Jan-13 (in house check)	In house check: Jan-14
Calibrator Box V2.1	SE UMS 006 AA 1002	07-Jan-13 (in house check)	In house check: Jan-14

Calibrated by:	Name R. Mayraz	Function Technician	Signature
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Approved by:	Name Fin Bornholt	Function Deputy Technical Manager	Signature
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Issued: January 25, 2013

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

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Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Glossary

DAE data acquisition electronics
Connector angle information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- **DC Voltage Measurement:** Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- **Connector angle:** The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - **DC Voltage Measurement Linearity:** Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - **Common mode sensitivity:** Influence of a positive or negative common mode voltage on the differential measurement.
 - **Channel separation:** Influence of a voltage on the neighbor channels not subject to an input voltage.
 - **AD Converter Values with inputs shorted:** Values on the internal AD converter corresponding to zero input voltage
 - **Input Offset Measurement:** Output voltage and statistical results over a large number of zero voltage measurements.
 - **Input Offset Current:** Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - **Input resistance:** Typical value for information: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - **Low Battery Alarm Voltage:** Typical value for information. Below this voltage, a battery alarm signal is generated.
 - **Power consumption:** Typical value for information. Supply currents in various operating modes.

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DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1 μ V, full range = -100...+300 mV
Low Range: 1LSB = 61nV, full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	404.011 \pm 0.02% (k=2)	404.006 \pm 0.02% (k=2)	403.901 \pm 0.02% (k=2)
Low Range	3.98819 \pm 1.55% (k=2)	3.99805 \pm 1.55% (k=2)	3.98192 \pm 1.55% (k=2)

Connector Angle

Connector Angle to be used in DASY system	117 ° \pm 1 °
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Appendix

1. DC Voltage Linearity

High Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	199994.16	-0.78	-0.00
Channel X + Input	20000.75	0.37	0.00
Channel X - Input	-19997.98	2.89	-0.01
Channel Y + Input	199995.20	0.02	0.00
Channel Y + Input	19999.08	-1.15	-0.01
Channel Y - Input	-20002.66	-1.66	0.01
Channel Z + Input	199994.67	-0.43	-0.00
Channel Z + Input	19997.92	-2.31	-0.01
Channel Z - Input	-20000.66	0.26	-0.00

Low Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	2001.23	0.59	0.03
Channel X + Input	201.53	0.55	0.28
Channel X - Input	-198.20	0.62	-0.31
Channel Y + Input	2000.33	-0.29	-0.01
Channel Y + Input	200.43	-0.68	-0.34
Channel Y - Input	-199.64	-0.69	0.35
Channel Z + Input	2000.78	0.22	0.01
Channel Z + Input	200.32	-0.69	-0.34
Channel Z - Input	-199.27	-0.35	0.18

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	-23.69	-25.75
	- 200	28.59	26.45
Channel Y	200	-1.44	-1.70
	- 200	-0.06	-0.16
Channel Z	200	-10.76	-11.18
	- 200	9.82	9.91

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	1.52	-4.72
Channel Y	200	8.54	-	4.31
Channel Z	200	10.79	5.34	-

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4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	16104	15986
Channel Y	16111	15993
Channel Z	16217	16069

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10M Ω

	Average (μ V)	min. Offset (μ V)	max. Offset (μ V)	Std. Deviation (μ V)
Channel X	1.28	0.53	2.45	0.33
Channel Y	-1.29	-2.89	0.51	0.58
Channel Z	-0.39	-1.47	1.06	0.37

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

	Zeroing (kOhm)	Measuring (MOhm)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9

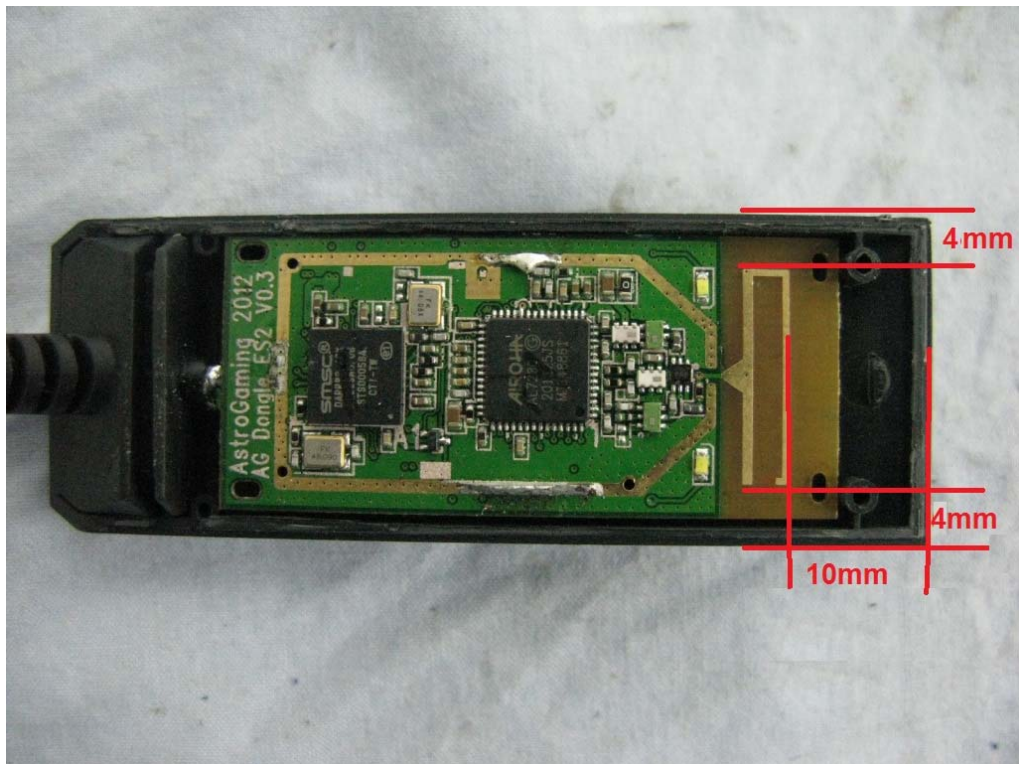
ANNEX G: The EUT Appearances and Test Configuration



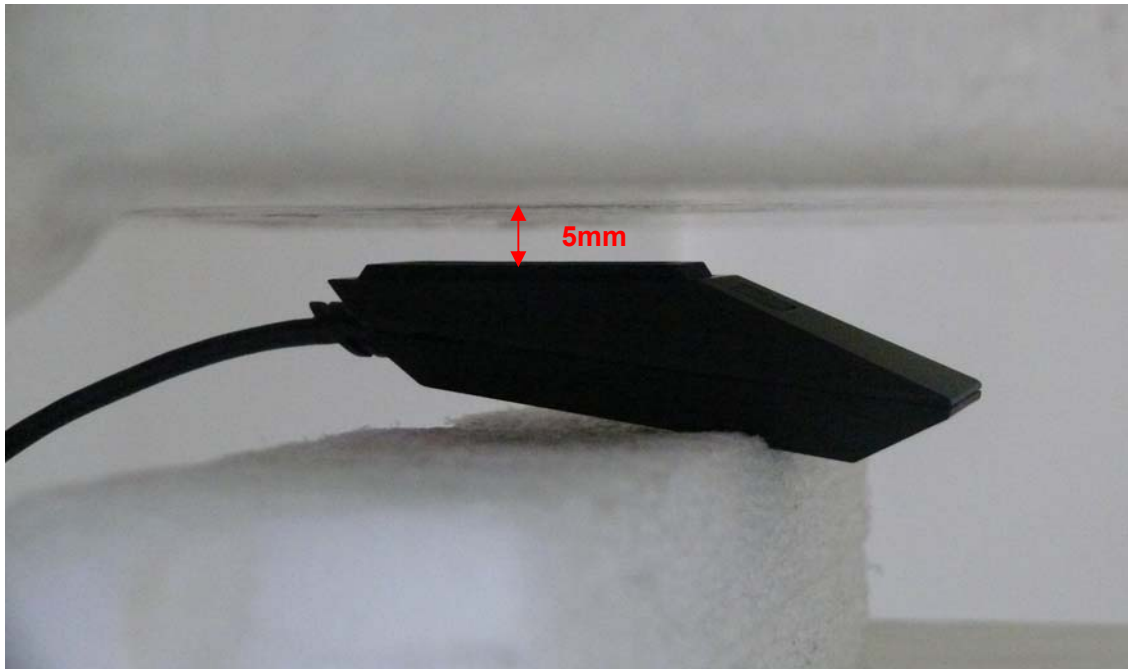
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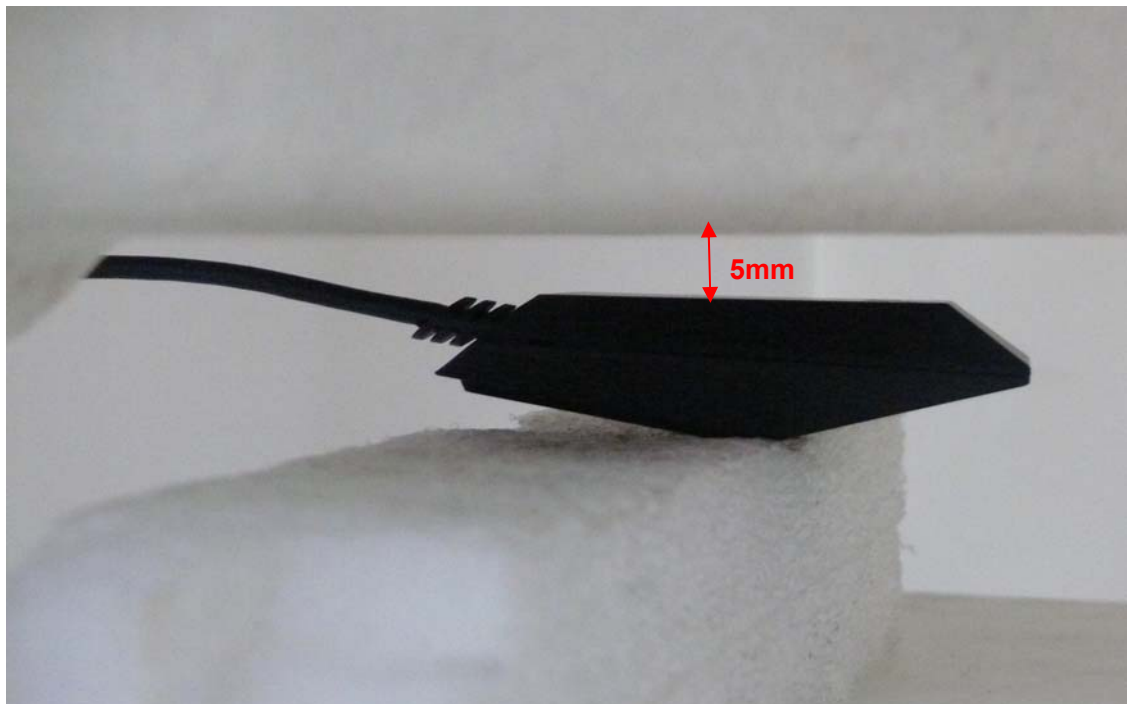
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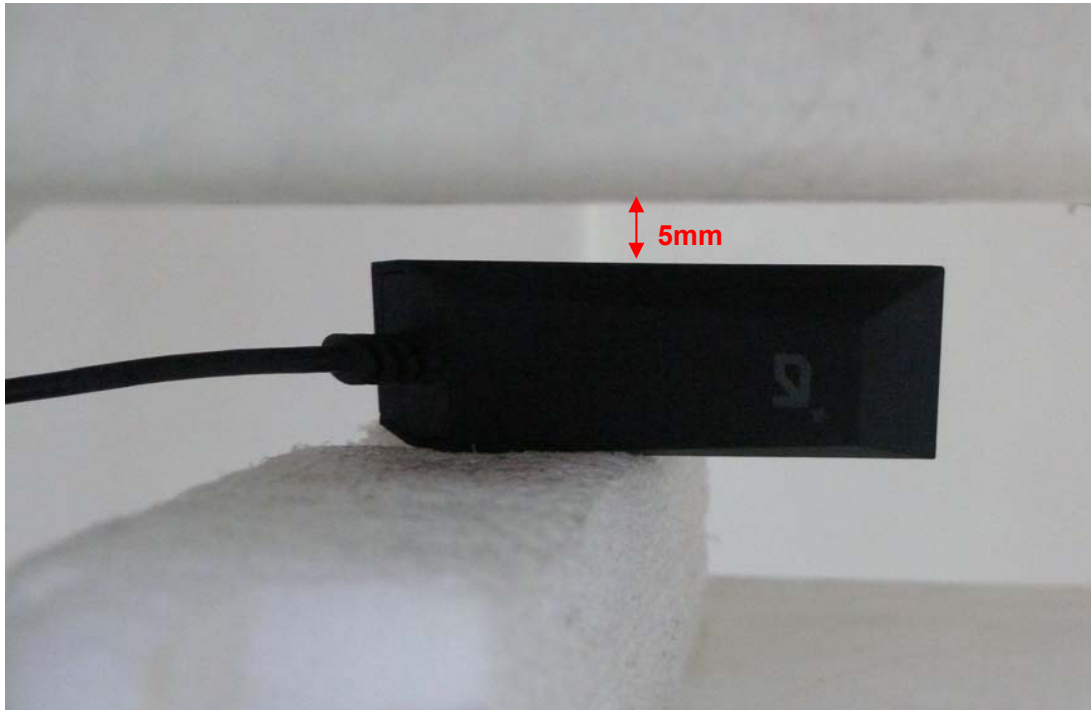
Picture 3: Constituents of the EUT



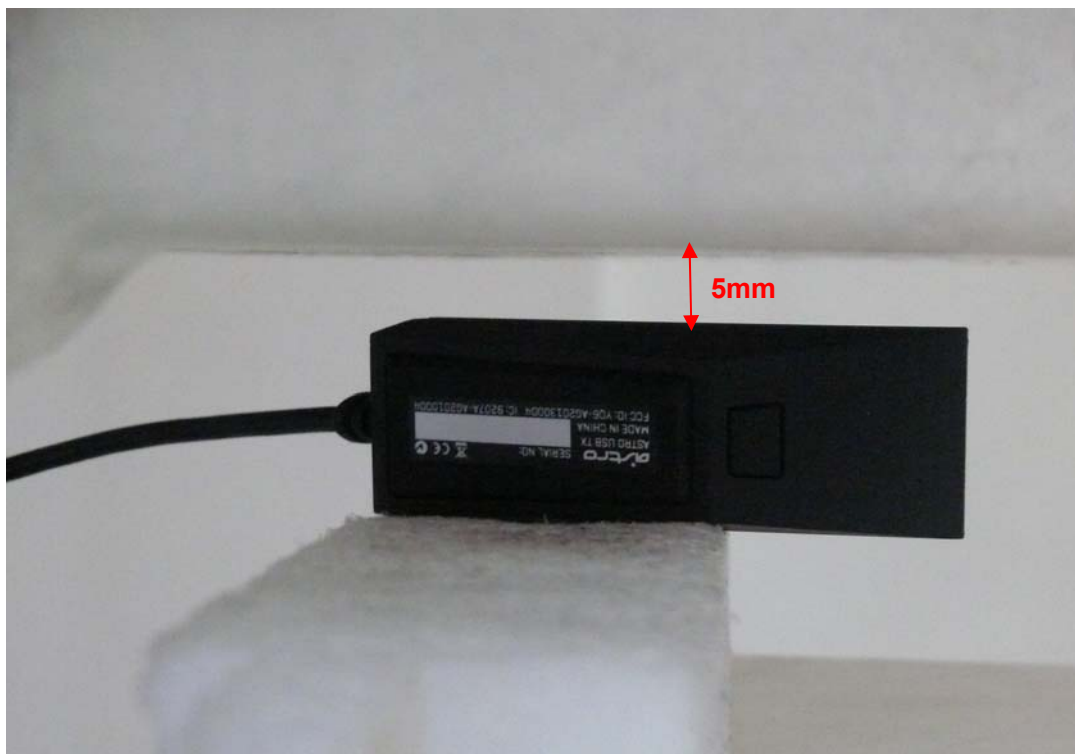
Picture 4: Test position 1



Picture 5: Test position 2



Picture 6: Test Position 3



Picture 7: Test Position 4



Picture 8: Test Position 5